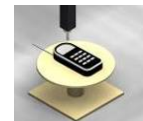




PCTEST ENGINEERING LABORATORY, INC.

6660-B Dobbin Road, Columbia, MD 21045 USA
Tel. 410.290.6652 / Fax 410.290.6554
<http://www.pctestlab.com>



HEARING AID COMPATIBILITY CERTIFICATE

Applicant Name:
LG Electronics USA
1000 Sylvan Avenue
Englewood Cliffs, NJ 07632
United States

Date of Testing:
March 1, 2006
Test Site/Location:
PCTEST Lab, Columbia, MD, USA
Test Report Serial No.:
HAC.0603010132-R1.BEJ

FCC ID: BEJCG300

APPLICANT: LG ELECTRONICS USA

Application Type: Class II Permissive Change
FCC Rule Part(s): § 20.19(b), §6.3(v), §7.3(v)
HAC Standard: ANSI C63.19-2006 v3.12
FCC Classification: Licensed Transmitter Held to Ear (PCE)
EUT Type: Dual-Band GSM Phone
Model(s): CG300
Tx Frequency: 824.20 MHz - 848.80 MHz (GSM 850) / 1850.20 - 1909.80 MHz (GSM PCS)

Test Device Serial No.: Pre-Production Sample [S/N: 602KPRW60390-CGR-P64]
Permissive Change(s): Update to C63.19-2006 v3.12 Compliance

C63.19 HAC Rated Category: M3 (RF EMISSIONS)

This wireless portable device has been shown to be hearing-aid compatible under the above rated category, specified in ANSI/IEEE Std. C63.19 and had been tested in accordance with the specified measurement procedures with the exceptions mentioned. Hearing-Aid Compatibility is based on the assumption that all production units will be designed electrically identical to the device tested in this report.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

NOTE: This revised Test Report (S/N: HAC.0603010132-R1.BEJ) supersedes and replaces the previously-issued test report on the same subject EUT for the same type of testing as indicated. Please discard or destroy the previously-issued report (S/N: HAC.0603010132.BEJ) and dispose of it accordingly.

PCTEST certifies that no party to this application has been denied the FCC benefits pursuant to Section 5301 of the Anti-Drug Abuse Act of 1988, 21 U.S.C. 862.

Randy Ortanez
President



FCC ID: BEJCG300	PCTEST	C63.19-2006 v3.12 HAC TEST REPORT	LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 1 of 70

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1. INTRODUCTION

On July 10, 2003, the Federal Communications Commission (FCC) adopted new rules requiring wireless manufacturers and service providers to provide digital wireless phones that are compatible with hearing aids. The FCC has modified the exemption for wireless phones under the Hearing Aid Compatibility Act of 1998 (HAC Act) in WT Docket 01-309 RM-8658¹ to extend the benefits of wireless telecommunications to individuals with hearing disabilities. These benefits encompass business, social and emergency communications, which increase the value of the wireless network for everyone. An estimated more than 10% of the population in the United States show signs of hearing impairment and of that fraction, almost 80% use hearing aids. Approximately 500 million people worldwide suffer from hearing loss.

Compatibility Tests Involved:

The standard calls for wireless communications devices to be measured for:

- RF Electric-field emissions
- RF Magnetic-field emissions
- T-coil mode, magnetic-signal strength in the audio band
- T-coil mode, magnetic-signal frequency response through the audio band
- T-coil mode, magnetic-signal and noise articulation index

The hearing aid must be measured for:

- RF immunity in microphone mode
- RF immunity in T-coil mode

In the following tests and results, this report includes the evaluation for a wireless communications device.

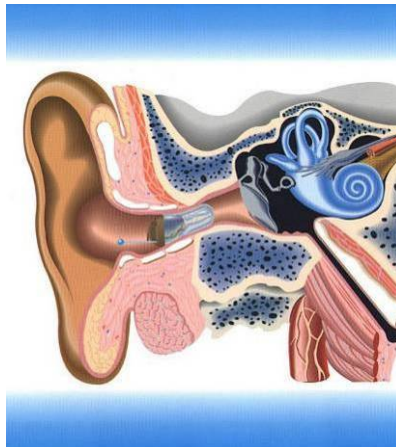


Figure 1-1 Hearing Aid *in-vitu*

¹ FCC Rule & Order, WT Docket 01-309 RM-8658

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2. TEST SITE LOCATION

2.1 INTRODUCTION

The map at the right shows the location of the PCTEST LABORATORY in Columbia, Maryland. It is in proximity to the FCC Laboratory, the Baltimore-Washington International (BWI) airport, the city of Baltimore and Washington, DC (See Figure 2).

These measurement tests were conducted at the PCTEST Engineering Laboratory, Inc. facility in New Concept Business Park, Guilford Industrial Park, Columbia, Maryland. The site address is 6660-B Dobbin Road, Columbia, MD 21045. The test site is one of the highest points in the Columbia area with an elevation of 390 feet above mean sea level. The site coordinates are 39° 11' 15" N latitude and 76° 49' 38" W longitude. The facility is 1.5 miles North of the FCC laboratory, and the ambient signal and ambient signal strength are approximately equal to those of the FCC laboratory. There are no FM or TV transmitters within 15 miles of the site. The detailed description of the measurement facility was found to be in compliance with the requirements of § 2.948 according to ANSI C63.4 on October 19, 2002.

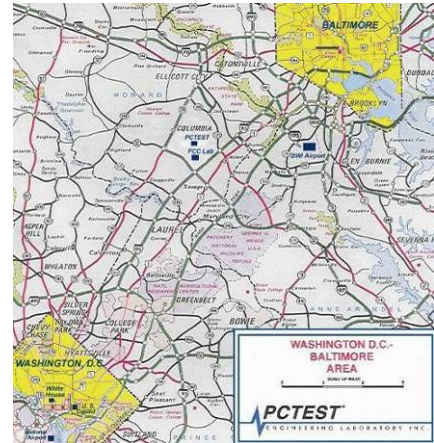
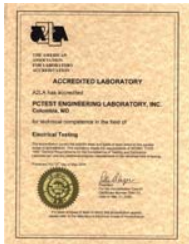


Figure 2-1

Map of the Greater Baltimore and Metropolitan Washington, D.C. area

2.2 Test Facility / A2LA Accreditation:

Measurements were performed at an independent accredited PCTEST Engineering Lab located in Columbia, MD 21045, U.S.A.



- PCTEST facility is an FCC registered (PCTEST Reg. No. 90864) test facility with the site description report on file and has met all the requirements specified in Section 2.948 of the FCC Rules and Industry Canada (IC 2451).
- PCTEST Lab is accredited to ISO 17025 by U.S. National Institute of Standards and Technology (NIST) under the National Voluntary Laboratory Accreditation Program (NVLAP Lab code: 100431-0) in EMC, FCC and Telecommunications.
- PCTEST Lab is accredited to ISO 17025 by the American Association for Laboratory Accreditation (A2LA) in Specific Absorption Rate (SAR) testing, CTIA Test Plans, and wireless testing for FCC, HAC, CTIA OTA and Industry Canada Rules.
- PCTEST Lab is a recognized U.S. Conformity Assessment Body (CAB) in EMC and R&TTE (n.b. 0982) under the U.S.-EU Mutual Recognition Agreement (MRA).
- PCTEST TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC Guide 65 by the American National Standards Institute (ANSI) in all scopes of FCC Rules.
- PCTEST facility is an IC registered (IC-2451) test laboratory with the site description on file at Industry Canada.
- PCTEST is a CTIA Authorized Test Laboratory (CATL) in AMPS and CDMA mobile phones.

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3. EUT DESCRIPTION



FCC ID: BEJCG300
Manufacturer: LG Electronics USA
1000 Sylvan Avenue
Englewood Cliffs, NJ 07632
United States
Trade Name: LGE
Model(s): CG300
Serial Number: 602KPRW60390-CGR-P64
Tx Frequencies: 824.20 MHz - 848.80 MHz (GSM 850)
1850.20 - 1909.80 MHz (GSM PCS)
Maximum Conducted Power (EMC/SAR): 32.7 dBm (GSM 850), 29.4 dBm (GSM PCS)
Maximum Conducted Power (HAC): 32.4 dBm (GSM 850), 29.4 dBm (GSM PCS)
HAC Test Configurations: 850 GSM, Channels 128, 190, 251
PCS GSM, Channels 512, 661, 810
FCC Classification: Licensed Transmitter Held to Ear (PCE)
EUT Type: Dual-Band GSM Phone



Figure 3-1
HAC RF Emissions Measurement System

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4. ANSI/IEEE C63.19 PERFORMANCE CATEGORIES

I. RF EMISSIONS

The ANSI Standard presents performance requirements for acceptable interoperability of hearing aids with wireless communications devices. When these parameters are met, a hearing aid operates acceptably in close proximity to a wireless communications device.

Category	Telephone RF Parameters	
Near field Category	E-field emissions CW dB(V/m)	H-field emissions CW dB(A/m)
f < 960 MHz		
M1	56 to 61 + 0.5 x AWF	5.6 to 10.6 +0.5 x AWF
M2	51 to 56 + 0.5 x AWF	0.6 to 5.6 +0.5 x AWF
M3	46 to 51 + 0.5 x AWF	-4.4 to 0.6 +0.5 x AWF
M4	< 46 + 0.5 x AWF	< -4.4 + 0.5 x AWF
f > 960 MHz		
M1	46 to 51 + 0.5 x AWF	-4.4 to 0.6 +0.5 x AWF
M2	41 to 46 + 0.5 x AWF	-9.4 to -4.4 +0.5 x AWF
M3	36 to 41 + 0.5 x AWF	-14.4 to -9.4 +0.5 x AWF
M4	< 36 + 0.5 x AWF	< -14.4 + 0.5 x AWF
Table 4-1 Hearing aid and WD near-field categories as defined in ANSI C63.19-2006 v3.12 [2]		

II. ARTICULATION WEIGHTING FACTOR (AWF)

Standard	Technology	Articulation Weighing Factor (AWF)
T1/T1P1/3GPP	UMTS (WCDMA)	0
IS-95	CDMA	0
iDEN™	TDMA (22 and 11 Hz)	0
J-STD-007	GSM (217 Hz)	-5
Table 4-2 Articulation Weighting Factors		

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5. SYSTEM SPECIFICATIONS

ER3DV6 E-Field Probe Description

Construction:	One dipole parallel, two dipoles normal to probe axis Built-in shielding against static charges
Calibration:	In air from 100 MHz to 3.0 GHz (absolute accuracy $\pm 6.0\%$, $k=2$)
Frequency:	100 MHz to > 6 GHz; Linearity: ± 0.2 dB (100 MHz to 3 GHz)
Directivity	± 0.2 dB in air (rotation around probe axis) ± 0.4 dB in air (rotation normal to probe axis)
Dynamic Range	2 V/m to > 1000 V/m (M3 or better device readings fall well below diode compression point)
Linearity:	± 0.2 dB
Dimensions	Overall length: 330 mm (Tip: 16 mm) Tip diameter: 8 mm (Body: 12 mm) Distance from probe tip to dipole centers: 2.5 mm

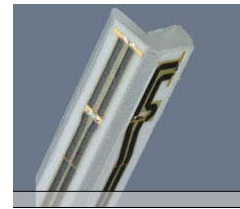


Figure 5-1
E-field Free-space
Probe

H3DV6 H-Field Probe Description

Construction:	Three concentric loop sensors with 3.8 mm loop diameters Resistively loaded detector diodes for linear response Built-in shielding against static charges
Frequency:	200 MHz to 3 GHz (absolute accuracy $\pm 6.0\%$, $k=2$); Output linearized
Directivity:	± 0.25 dB (spherical isotropy error)
Dynamic Range:	10 mA/m to 2 A/m at 1 GHz (M3 or better device readings fall well below diode compression point)
Dimensions:	Overall length: 330 mm (Tip: 40 mm) Tip diameter: 6 mm (Body: 12 mm) Distance from probe tip to dipole centers: 3 mm
E-Field Interference:	< 10% at 3 GHz (for plane wave)



Figure 5-2
H-Field Free-space
Probe

Probe Tip Description

HAC field measurements take place in the close near field with high gradients. Increasing the measuring distance from the source will generally decrease the measured field values (in case of the validation dipole approx. 10% per mm).

Magnetic field sensors are measuring the integral of the H-field across their sensor area surrounded by the loop. They are calibrated in a precise, homogeneous field. When measuring a gradient field, the result will be very close to the field in the center of the loop which is equivalent to the value of a homogeneous field equivalent to the center value. But it will be different from the field at the border of the loop.

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Consequently, two sensors with different loop diameters - both calibrated ideally - would give different results when measuring from the edge of the probe sensor elements. The behavior for electrically small E-field sensors is equivalent. See below for distance plots from a WD which show the conservative nature of field readings at the probe element center vs. measurements at the sensor end:

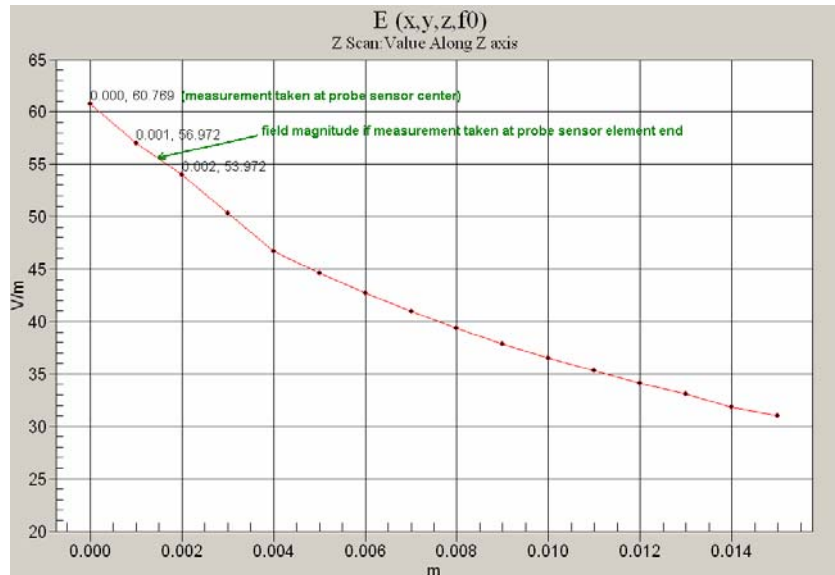


Figure 5-3 Z-axis scan at maximum point above a typical wireless device for E-field

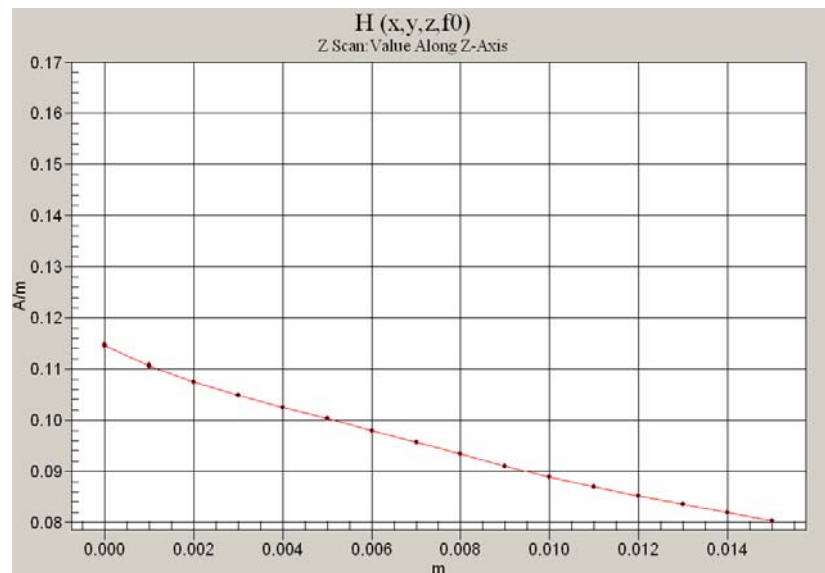


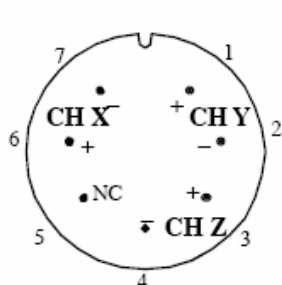
Figure 5-4 Z-Axis Scan at maximum point above a typical wireless device for H-field

The magnetic field loops of the H3D probes are concentric, with the center 3mm from the tip for H3DV6. Their radius is 1.9mm.

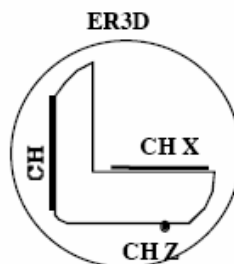
The electric field probes have a more irregular internal geometry because it is physically not possible to have the 3 orthogonal sensors situated with the same center. The effect of the different sensor centers is accounted for in the HAC uncertainty budget ("sensor displacement"). Their geometric center is at 2.5mm from the tip, and the element ends are 1.1mm closer to the tip.

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Connector Plan



(seen from back)



(seen from front)

The antistatic shielding inside the probe is connected to the probe connector case.

It is recommended to connect the probes with the amplifier using a short and well shielded cable and to connect the cable shielding with the connector case.

Instrumentation Chain

Equation 1

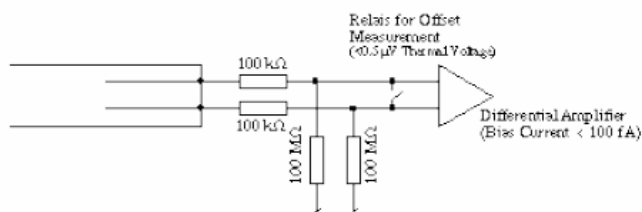
Conversion of Connector Voltage u_i to E-Field E_i

$$E_i = \sqrt{\frac{u_i + (u_i^2 \cdot CF) / (DCP)}{Norm_i \cdot ConvF}}$$

whereby

E_i : electric field in V/m
 u_i : voltage of channel i at the connector in μV
 $Norm_i$: sensitivity of channel i in $\mu V / (V/m)^2$
 $ConvF$: enhancement factor in liquid ($ConvF=1$ for Air)
 DCP : diode compression point in μV
 CF : signal crest factor (peak power/average power)

Conditions of Calibration



Please note:

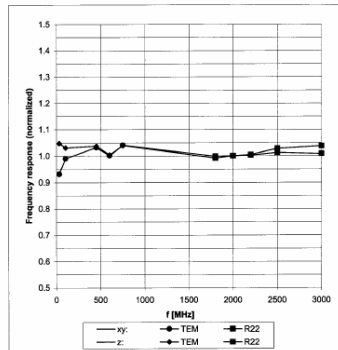
- a lower input impedance of the amplifier will result in different sensitivity factors $Norm_i$ and DCP
- larger bias currents will cause higher offset

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Probe Response to Frequency

The E-field sensors have inherently a very flat frequency response. They are calibrated with a number of frequencies resulting in a common calibration factor, with the frequency behavior documented in the calibration certificate (See also below).

Frequency Response of E-Field
(TEM-Cell: if110 EXX, Waveguide R22)

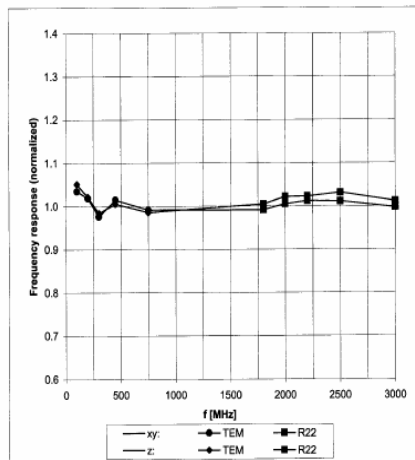


Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

Figure 5-5 E-Field Probe Frequency Response

H-field sensors have a frequency dependent sensitivity which is evaluated for a series of frequencies also visible in the probe calibration certificate. The calibration factors result from a fitting algorithm. The proper conversion is calculated by the DASY4 software depending on the frequency setting in the procedure. See below for H-field frequency response:

Frequency Response of H-Field
(TEM-Cell: if110, Waveguide R22)



Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

Figure 5-6 H-Field Probe Frequency Response

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Conversion to Peak

Peak is defined as Peak Envelope Power. All raw measurements from the HAC measurement system are RMS values. The DASY4 system incorporates the crest factor of the signal in the computation of the RMS values (See Equation 1). Although the software also has capability to estimate the peak field by applying a square root of crest factor value to the readings, the probe modulation factor was applied manually instead per PC63.19 in the measurement tables in this report. The equation to convert the raw measurements in the data tables are:

$$\text{Peak Field} = 20 \cdot \log (\text{Raw} \cdot \text{PMF})$$

Where:

Peak Field = Peak field (in dBV/m or dBA/m)

Raw = Raw field measurement from the measurement system (in V/m or A/m).

PMF = Probe Modulation Factor (in linear units).

SPEAG Robotic System

E-field and H-field measurements are performed using the DASY4 automated dosimetric assessment system. The DASY4 is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland and consists of high precision robotics system (Staubli), robot controller, Pentium 4 computer, near-field probe, probe alignment sensor, and the HAC phantom. The robot is a six-axis industrial robot performing precise movements to position the probe to the location (points) of maximum electromagnetic field (EMF).



Figure 5-7
SPEAG Robotic System



Figure 5-8
PCTEST Lab Acoustics Facility

System Hardware

A cell controller system contains the power supply, robot controller, teach pendant (Joystick), and a remote control used to drive the robot motors. The PC consists of the Gateway Pentium 4 2.53 GHz computer with Windows XP system and RF Measurement Software DASY4 v4.5 (with HAC Extension), A/D interface card, monitor, mouse, and keyboard. The Staubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit that performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler

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(EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

System Electronics

The DAE consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.

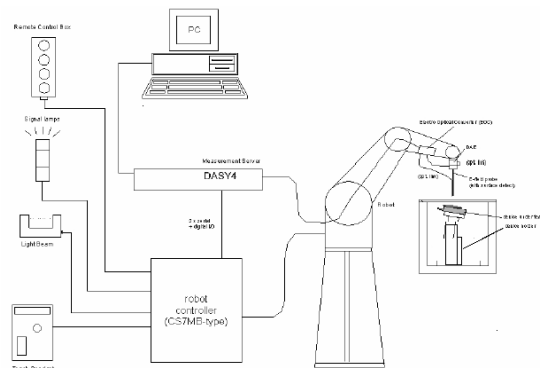


Figure 5-9
SPEAG Robotic System Diagram

DASY4 Instrumentation Chain

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power. The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \cdot \frac{cf}{dcp_i}$$

- with

V_i

= compensated signal of channel i

(i = x, y, z)

U_i

= input signal of channel i

(i = x, y, z)

cf

= crest factor of exciting field

(DASY parameter)

dcp_i

= diode compression point

(DASY parameter)

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From the compensated input signals the primary field data for each channel can be evaluated:

$$\text{E - fieldprobes :} \quad E_i = \sqrt{\frac{V_i}{Norm_i \cdot ConvF}}$$

$$\text{H - fieldprobes :} \quad H_i = \sqrt{V_i} \cdot \frac{a_{i0} + a_{i1}f + a_{i2}f^2}{f}$$

with V_i = compensated signal of channel i (i = x, y, z)
 $Norm_i$ = sensor sensitivity of channel i (i = x, y, z)
 $\mu\text{V}/(\text{V}/\text{m})^2$ for E-field Probes
 $ConvF$ = sensitivity enhancement in solution
 a_{ij} = sensor sensitivity factors for H-field probes
 f = carrier frequency [GHz]
 E_i = electric field strength of channel i in V/m
 H_i = magnetic field strength of channel i in A/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{tot} = \sqrt{E_x^2 + E_y^2 + E_z^2}$$

The primary field data are used to calculate the derived field units.

The measurement/integration time per point, as specified by the system manufacturer is >500 ms.

The signal response time is evaluated as the time required by the system to reach 90% of the expected final value after an on/off switch of the power source with an integration time of 500 ms and a probe response time of <5 ms. In the current implementation, DASY4 waits longer than 100 ms after having reached the grid point before starting a measurement, i.e., the response time uncertainty is negligible.

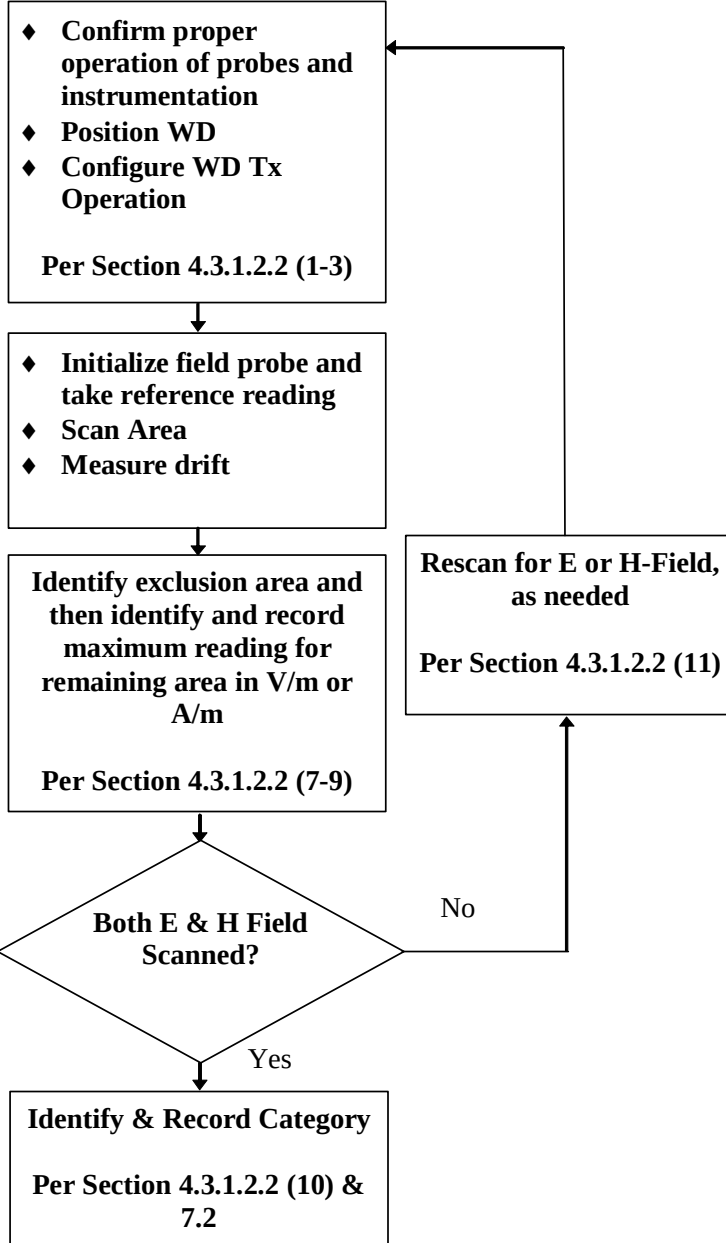
If the device under test does not emit a CW signal, the integration time applied to measure the electric field at a specific point may introduce additional uncertainties due to the discretization. The tolerances for the different systems had the worst-case of 2.6%.

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6. TEST PROCEDURE

I. RF EMISSIONS

Test Instructions



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Test Setup

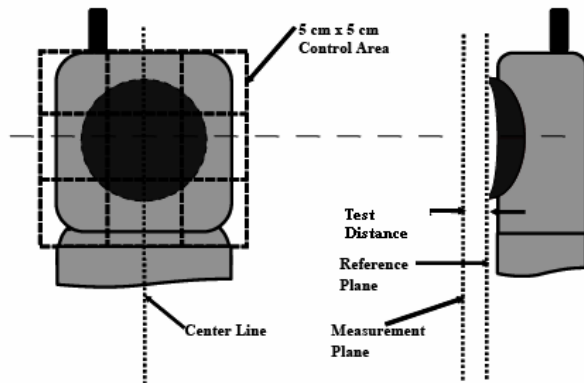


Figure 6-1
E/H-Field Emissions Test Setup Diagram

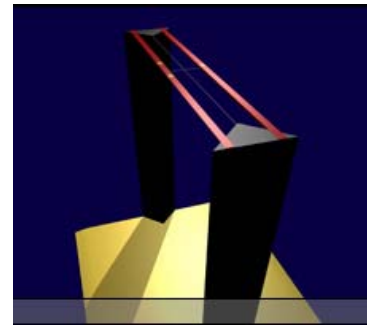


Figure 6-2
HAC Phantom

RF Emissions Test Procedure:

The following illustrate a typical RF emissions test scan over a wireless communications device:

1. Proper operation of the field probe, probe measurement system, other instrumentation, and the positioning system was confirmed.
2. WD is positioned in its intended test position, acoustic output point of the device perpendicular to the field probe.
3. The WD operation for maximum rated RF output power was configured and confirmed with the base station simulator, at the test channel and other normal operating parameters as intended for the test. The battery was ensured to be fully charged before each test.
4. The center sub-grid was centered over the center of the acoustic output (also audio band magnetic output, if applicable). The WD audio output was positioned tangent (as physically possible) to the measurement plane.
5. A surface calibration was performed before each setup change to ensure repeatable spacing and proper maintenance of the measurement plane using the HAC Phantom.
6. The measurement system measured the field strength at the reference location.
7. Measurements at 2mm increments in the 5 x 5 cm region were performed and recorded 1 cm tangent from the handset ERP and the probe element ends. A 360° rotation about the azimuth axis at the maximum interpolated position was measured. For the worst-case condition, the peak reading from this rotation was used in re-evaluating the HAC category.
8. The system performed a drift evaluation by measuring the field at the reference location.
9. Steps 1-8 were done for both the E and H-Field measurements.

FCC ID: BEJCG300	 PCTEST Engineering Laboratory, Inc.	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 15 of 70

7. SYSTEM CHECK

I. System Check Parameters

The input signal was an un-modulated continuous wave. The following points were taken into consideration in performing this check:

- Average Input Power $P = 100\text{mW RMS}$ (20dBm RMS) after adjustment for return loss
- The test fixture must meet the 2 wavelength separation criterion
- The proper measurement of the 1 cm probe to dipole separation, which is measured from top surface of the dipole to the calibration reference point of the sensor, defined by the probe manufacturer is shown in the following diagram:

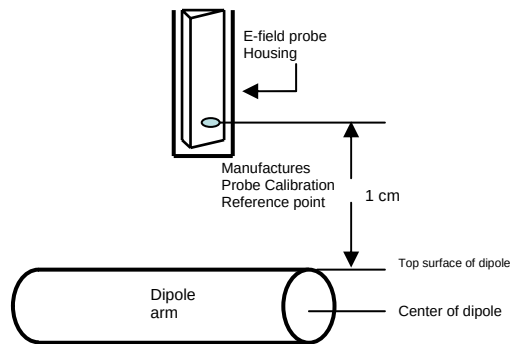


Figure 7-1
Separation Distance from Dipole to Field Probe

RF power was recorded using both an average reading meter and a peak reading meter. Readings of the probe are provided by the measurement system.

To assure proper operation of the near-field measurement probe the input power to the dipole shall be commensurate with the full rated output power of the wireless device (e.g. - for a cellular phone wireless device the average peak antenna input power will be on the order of 100mW (i.e. - 20dBm) RMS after adjustment for any mismatch.

II. Validation Procedure

A dipole antenna meeting the requirements given in PC63.19 was placed in the position normally occupied by the WD.

The length of the dipole was scanned with both E-field and H-field probes and the maximum values for each were recorded.

Measurement of CW

Using the near-field measurement system, scan the antenna over the radiating dipole and record the greatest field reading observed. Due to the nature of E-fields about free-space dipoles, the two E-field peaks measured over the dipole are averaged to compensate for non-parallelity of the setup (see manufacturer method on dipole calibration certificates, page 2. Field strength measurements shall be made only when the probe is stationary.

FCC ID: BEJCG300	 PCTEST wired & wireless	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 16 of 70

RF power was recorded using both an average and a peak power reading meter.

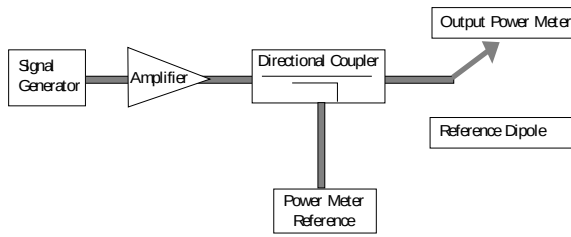


Figure 7-2

Setup for Desired Output Power to Dipole

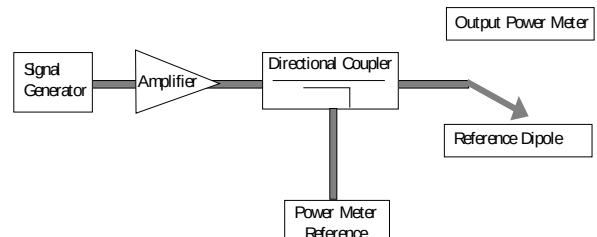


Figure 7-3

Setup to Dipole

Using this setup configuration, the signal generator was adjusted for the desired output power (100mW) at a specified frequency. The reference power from the coupled port of the directional coupler is recorded. Next, the output cable is connected to the reference dipole, as shown in Figure 7-3.

The input signal level was adjusted until the reference power from the coupled port of the directional coupler was the same as previously recorded, to compensate for the impedance mismatch between the output cable and the reference dipole. To assure proper operation of the near-field measurement probe the input power to the reference dipole was verified to the full rated output power of the wireless device. The dipole was secured in a holder in a manner to meet the 20 dB reflection. The near-field measurement probe was positioned over the dipole. The antenna was scanned over the appropriate sized area to cover the dipole from end to end. SPEAG uses 2D interpolation algorithms between the measured points. Please see below two dimensional plots showing that the interpolated values interpolate smoothly between 5mm steps for a free-space RF dipole:

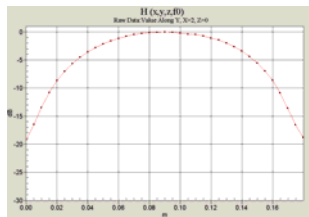


Figure 7-4

2-D Raw Data from scan along dipole axis

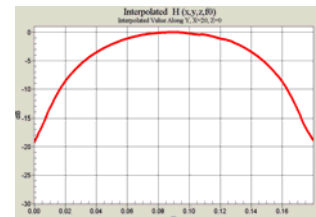


Figure 7-5

2-D Interpolated points from scan along dipole axis

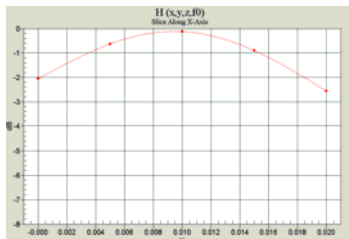


Figure 7-6

2-D Raw Data from scan along transverse axis

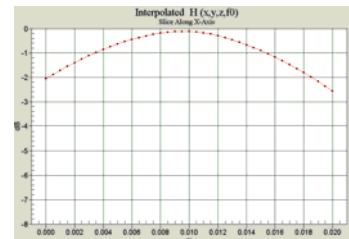


Figure 7-7

2-D Interpolated points from scan along transverse axis

III. System Check Results

FCC ID: BEJCG300	 PCTEST Engineering Laboratory, Inc.	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 17 of 70

Validation Results

Frequency (MHz)	Input Power (dBm)	E-field Result (V/m)	Target Field (V/m)	% Deviation
835	20.0	169.8	185.1	-8.3%
1880	20.0	144.8	145.8	-0.7%

Frequency (MHz)	Input Power (dBm)	H-field Result (A/m)	Target Field (A/m)	% Deviation
835	20.0	0.474	0.470	0.9%
1880	20.0	0.425	0.450	-5.6%

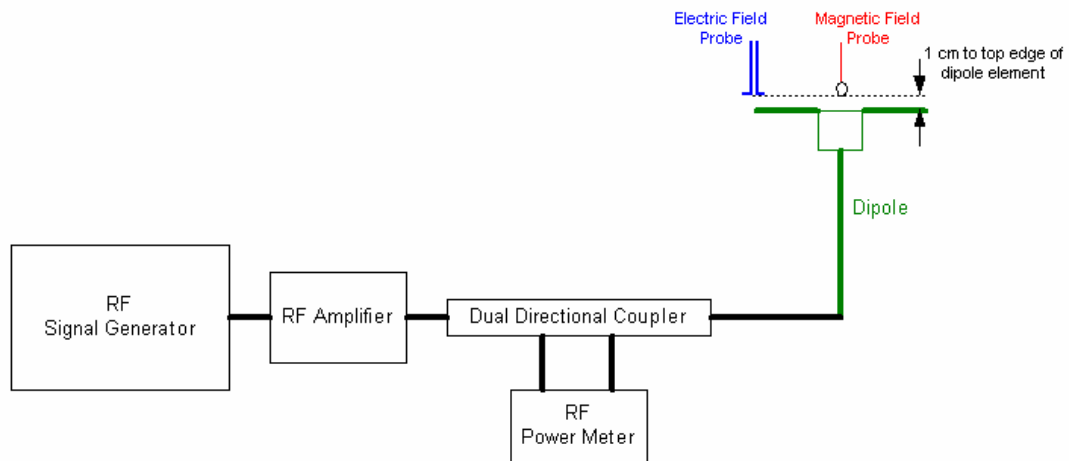


Figure 7-8
System Check Setup

FCC ID: BEJCG300	 PCTEST Engineering Laboratory, Inc.	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 18 of 70

8. MODULATION FACTOR

A calibration was made of the modulation response of the probe and its instrumentation chain. This calibration was performed with the field probe, attached to its instrumentation. The response of the probe system to a CW field at the frequency of interest is compared to its response to a modulated signal with equal peak amplitude to that of a CW signal. The field level of the test signals are ensured to be more than 10 dB above the ambient level and the noise floor of the instrumentation being used. The ratio of the CW reading to that taken with a modulated reading was applied to the DUT measurements.

This was done using the following procedure:

1. The probe was illuminated with a CW signal at the intended measurement frequency.
2. The probe was positioned at the field maxima over the dipole antenna (determined after an area scan over the dipole).
3. The reading of the probe measurement system of the CW signal at the maximum point was recorded.
4. Using a Spectrum Analyzer, the modulated signal adjusted with the same peak level of the CW signal was determined.
5. The probe measurement system reading was recorded with the modulated signal.
6. The ratio of the CW reading to modulated signal reading is the probe modulation factor (PMF) for the modulation and field probe combination.
7. Steps 1-6 were repeated at all frequency bands and for both E and H field probes.

The modulation factors obtained were applied to readings taken of the actual wireless device, in order to obtain an accurate peak field reading using the formula:

$$\text{Peak} = 20 \cdot \log(\text{Raw} \cdot \text{PMF})$$

Modulation Factors:

f (MHz)	Peak Power (dBm)	Protocol	E-Field (V/m)	H-Field (A/m)	E-Field Modulation Factor	H-Field Modulation Factor
835	33.0	AM	558.9	1.986	1.494	1.176
835	33.0	GSM	281	1.121	2.972	2.084
835	33.0	CW	835.2	2.336		
1880	30.0	AM	296.5	1.323	1.351	1.120
1880	30.0	GSM	144.5	0.6907	2.772	2.146
1880	30.0	CW	400.5	1.482		

Figure 8-1
Modulation Factors

FCC ID: BEJCG300	 PCTEST wiredless	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 19 of 70

Spectrum Analyzer Plots of ESG-D Signal used for PMF measurements:

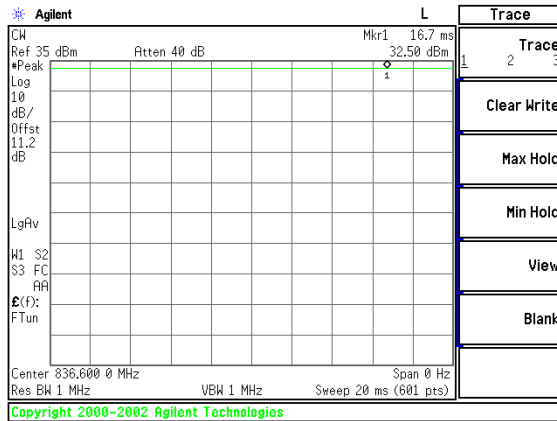


Figure 8-2 GSM850 CW Signal

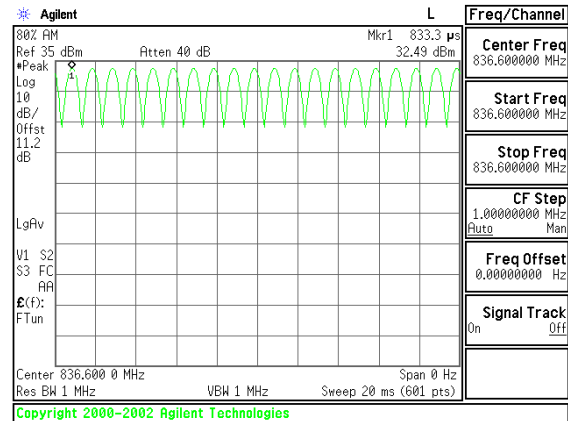


Figure 8-3 GSM850 80% AM Signal

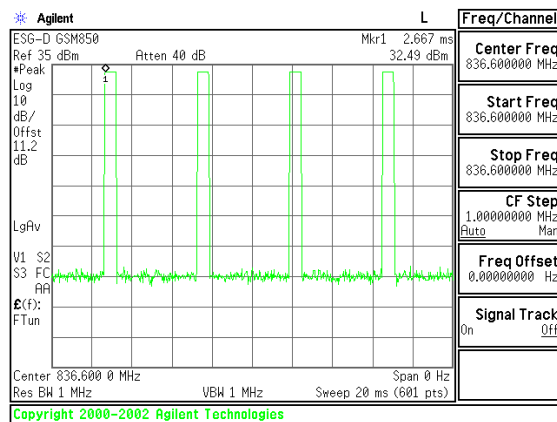


Figure 8-4 GSM850 Signal

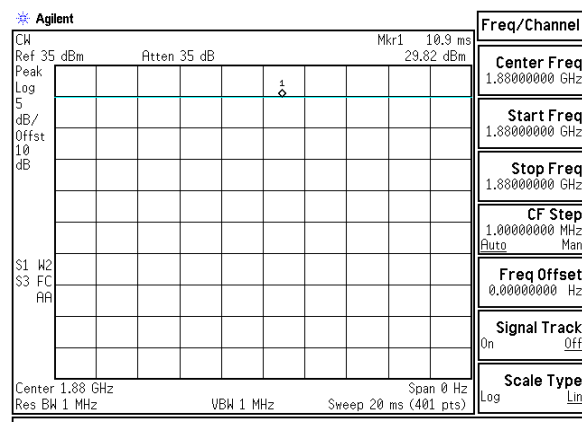


Figure 8-5 PCS CW Signal

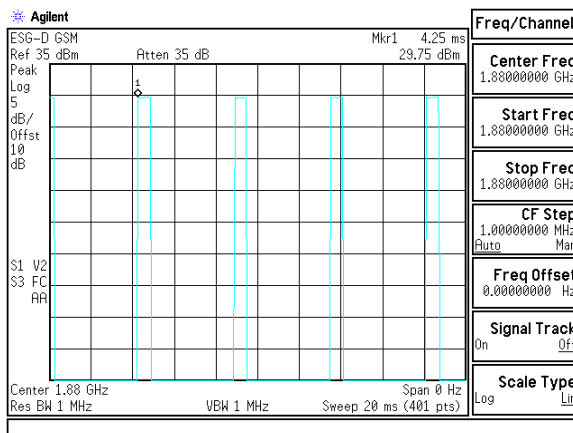


Figure 8-6 PCS GSM Signal

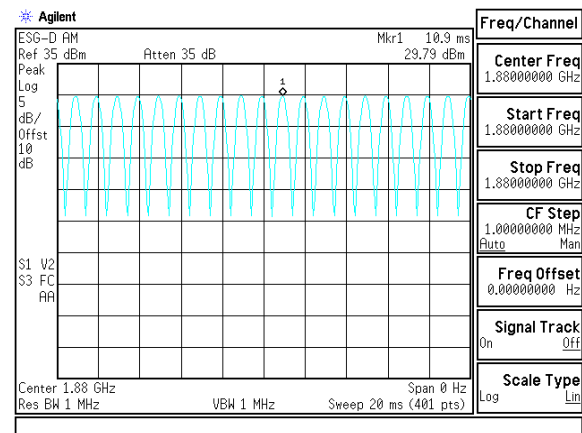


Figure 8-7 PCS 80% AM Signal

FCC ID: BEJCG300	 PCTEST Engineering Laboratory, Inc.	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 20 of 70

9. OVERALL MEASUREMENT SUMMARY

FCC ID:	BEJCG300
Model:	CG300
S/N:	602KPRW60390-CGR-P64

I. E-FIELD EMISSIONS:

Table 9-1
HAC Data Summary for E-field

Mode	Channel	Backlight	Antenna	Conducted Power at BS (dBm)	Time Avg. Field (V/m)	Peak Field (dBV/m)	FCC Limit (dBV/m)	FCC MARGIN (dB)	RESULT	Excl Blocks per 4.3.1.2.2
E-field Emissions										
GSM850	128	off	Fixed	32.20	62.9	45.2	48.50	-3.35	M3	1, 2, 3
GSM850	190	off	Fixed	32.06	63.6	45.2	48.50	-3.25	M3	1, 2, 3
GSM850	251	off	Fixed	32.46	61.7	45.0	48.50	-3.52	M3	1, 2, 3
GSM1900	512	off	Fixed	29.18	24.4	36.7	38.50	-1.80	M3	7, 8, 9
GSM1900	661	off	Fixed	29.46	27.7	37.8	38.50	-0.70	M3	6, 8, 9
GSM1900	810	off	Fixed	29.25	29.7	38.4	38.50	-0.09	M3	6, 8, 9
GSM1900	810	on	Fixed	29.25	29.0	38.2	38.50	-0.30	M3	6, 8, 9
GSM1900	810	off	Fixed	29.25	24.4	36.7	38.50	-1.80	M3	6, 8, 9
GSM1900	810	off	Fixed	29.25	20.5	35.2	38.50	-3.31	M3	6, 8, 9

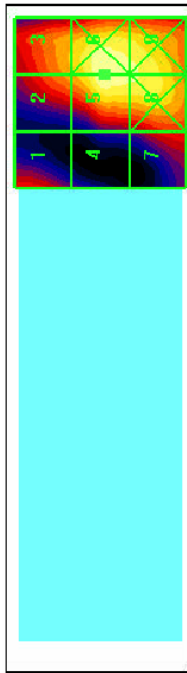


Figure 9-1
Sample E-field Scan Overlay
(See Test Setup Photographs for actual WD overlay)

FCC ID: BEJCG300	 PCTEST wired	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 21 of 70

FCC ID:	BEJCG300
Model:	CG300
S/N:	602KPRW60390-CGR-P64

II. H-FIELD EMISSIONS:

Table 9-2
HAC Data Summary for H-field

Mode	Channel	Backlight	Antenna	Conducted Power at BS (dBm)	Time Avg. Field (A/m)	Peak Field (dBA/m)	FCC Limit (dBA/m)	FCC MARGIN (dB)	RESULT	Excl Blocks per 4.3.1.2.2
H-field Emissions										
GSM850	128	off	Fixed	32.20	0.087	-14.6	-1.9	-12.69	M4	1, 4, 7
GSM850	190	off	Fixed	32.06	0.090	-14.3	-1.9	-12.39	M4	1, 4, 7
GSM850	251	off	Fixed	32.46	0.089	-14.4	-1.9	-12.49	M4	1, 4, 7
GSM1900	512	off	Fixed	29.18	0.047	-19.6	-11.9	-7.66	M4	1, 4, 7
GSM1900	661	off	Fixed	29.46	0.040	-21.0	-11.9	-9.06	M4	4, 7, 8
GSM1900	810	off	Fixed	29.25	0.053	-18.5	-11.9	-6.62	M4	4, 7, 8

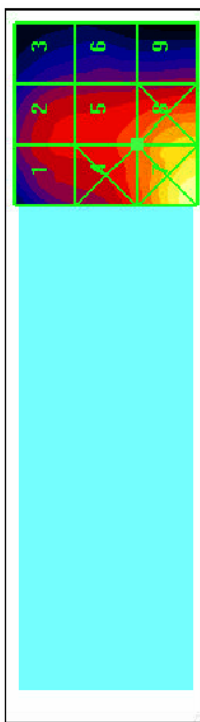


Figure 9-2
Sample H-field Scan Overlay
(See Test Setup Photographs for actual WD overlay)

FCC ID: BEJCG300	 PCTEST Engineering Laboratory, Inc.	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 22 of 70

FCC ID:	BEJCG300
Model:	CG300
S/N:	602KPRW60390-CGR-P64

III. Worst-case Configuration Evaluation

Table 9-3
Peak Reading 360° Probe Rotation at Azimuth axis

Mode	Channel	Backlight	Antenna	Conducted Power at BS (dBm)	Time Avg. Field (V/m)	Peak Field (dBV/m)	FCC Limit (dBV/m)	FCC MARGIN (dB)	RESULT
Probe Rotation at Worst-Case									
GSM1900	810	off	Fixed	29.25	29.7	38.4	38.50	-0.09	M3

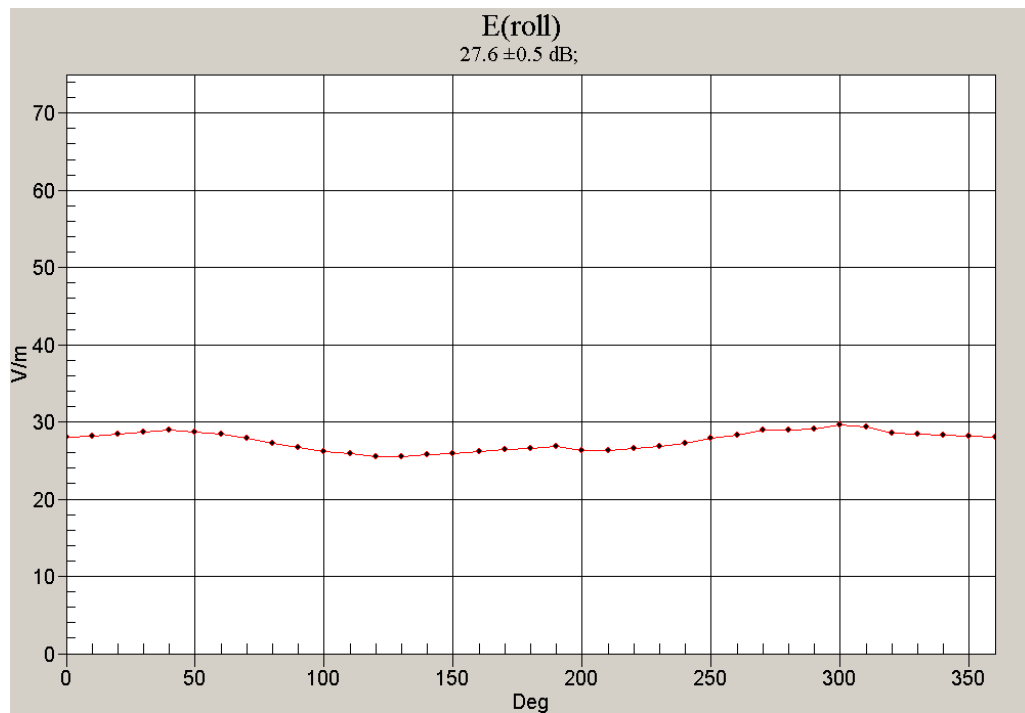


Figure 9-3
Worst-Case Probe Rotation about Azimuth axis

* Note: Location of probe rotation is shown in Figure 9-1 or Figure 9-2

FCC ID: BEJCG300	 PCTEST Engineering Laboratory, Inc.	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
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10. EQUIPMENT LIST

Manufacturer	Make / Equipment	Calibration Due	Asset No.
HP	437B Power Meter	May 2006	3125U24437
Amplifier Research	5S1G4 (5W, 800MHz-4.2GHz)	January 2007	22322
Gigatronics	80701A (0.05-18GHz) Power Sensor	April 2006	1833460
HP	8482H (30mW-3W) Power Sensor	February 2007	2237A02084
HP	8594A Spectrum Analyzer	February 2007	3051A00187
Gigatronics	8657A Universal Power Meter	April 2006	1835256
HP	8753E (30kHz-6GHz) Network Analyzer	February 2007	JP38020182
Agilent	8960 Base Station Simulator	January 2007	PCT080
Agilent	Base Station Simulator	May 2006	661
Rohde & Schwarz	CMD80 Base Station Simulator	June 2006	830805/005
Rohde & Schwarz	CMU200 Base Station Simulator	October 2006	650378
Agilent	ESG-D Signal Generator	October 2006	PCT800
Optix	Fiber-Optic Line	N/A	
SPEAG	Freespace 1880 MHz Dipole	February 2007	1002
SPEAG	Freespace 1900 MHz Dipole	February 2007	1002
SPEAG	Freespace 2450 MHz Dipole	February 2007	1004
SPEAG	Freespace H-field Probe	August 2006	6170
SPEAG	Freespace E-field Probe	August 2006	2353
Brüel & Kjær	HATS System	January 2007	687
Hosa	High Precision TRS Cable	N/A	
EMCO	Model 3115 (1-18GHz) Horn Antenna	October 2006	9203-2178
EMCO	Model 3115 (1-18GHz) Horn Antenna	October 2006	9704-5182
Rohde & Schwarz	NRVS Power Meter	June 2007	
RF Lindgren Model 26-2/2-0	Shielded Screen Room	N/A	6710 (PCT270)
MicroCoax	(1.0-26.5GHz) Microwave Cables	N/A	N/A
HP	8648D (9kHz-4GHz) Signal Generator	October 2006	3613A00315
Rohde & Schwarz	(0.1-1000MHz) Signal Generator	September 2006	894215/012
Ray Proof Model S81	Shielded Semi-Anechoic Chamber	N/A	R2437 (PCT278)
Narda	3020A (50-1000MHz) Bi-Directional Coax Coupler	January 2007	
HP	8901A Modulation Analyzer	January 2007	2432A03467
HP	8903B Audio Analyzer	January 2007	3011A09025

Table 10-1
Equipment List

*Calibration traceable to the National Institute of Standards and Technology (NIST).

FCC ID: BEJCG300	 PCTEST Engineering Laboratory, Inc.	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 24 of 70

11. MEASUREMENT UNCERTAINTY

Wireless Communications Device Near-Field Measurement Uncertainty Estimation						
Uncertainty Component	Data (dB)	Data Type	Prob. Dist.	Divisor	Unc. (dB)	Notes/Comments
Measurement System						
RF System Reflections	0.50	Tolerance	R	1.73	0.30	* Refl. < -20 dB
RF Ambient Conditions	0.20	Tolerance	R	1.73	0.12	
Field Probe Conversion Factor	0.42	Tolerance	R	1.73	0.25	
Field Probe Isotropy	0.11	Tolerance	R	1.73	0.06	
Field Probe Frequency Response	0.135	Tolerance	R	1.73	0.08	
Field Probe Linearity	0.025	Tolerance	R	1.73	0.01	
Boundary Effects	0.105	Accuracy	R	1.73	0.06	
Sensor Displacement	0.66	Accuracy	R	1.73	0.39	*
Probe Positioning Accuracy	0.20	Accuracy	R	1.73	0.12	*
Probe Positioner	0.050	Accuracy	R	1.73	0.03	*
Extrapolation/Interpolation	0.045	Tolerance	R	1.73	0.03	*
System Detection Limit	0.05	Tolerance	R	1.73	0.03	*
Readout Electronics	0.015	Tolerance	N	1.00	0.02	*
Integration Time	0.11	Tolerance	R	1.73	0.06	*
Response Time	0.033	Tolerance	R	1.73	0.02	*
Phantom Thickness	0.10	Tolerance	R	1.73	0.06	*
Test Sample Related						
Device Positioning Vertical	0.4	Tolerance	R	1.73	0.24	*
Device Positioning Lateral	0.045	Tolerance	N	1	0.05	*
Device Holder and Phantom	0.1	Tolerance	R	1.73	0.06	*
Power Drift	0.21	Tolerance	N	1	0.21	
Combined Standard Uncertainty (k=1)					0.65	16.1%
Expanded Uncertainty (k=2) [95% confidence]					1.30	32.3%

Table 11-1
Uncertainty Estimation Table

Notes:

1. Test equipment are calibrated according to techniques outlined in NIS81, NIS3003 and NIST Tech Note 1297. All equipment have traceability according to NIST. Measurement Uncertainties are defined in further detail in NIS 81 and NIST Tech Note 1297 and UKAS M3003.
2. * Uncertainty specifications from Schmidt & Partner Engineering AG (not site specific)

Measurement uncertainty reflects the quality and accuracy of a measured result as compared to the true value. Such statements are generally required when stating results of measurements so that it is clear to the intended audience that the results may differ when reproduced by different facilities. Measurement results vary due to the measurement uncertainty of the instrumentation, measurement technique, and test engineer. Most uncertainties are calculated using the tolerances of the instrumentation used in the measurement, the measurement setup variability, and the technique used in performing the test. While not generally included, the variability of the equipment under test also figures into the overall measurement uncertainty. Another component of the overall uncertainty is based on the variability of repeated measurements (so-called Type A uncertainty). This may mean that the Hearing Aid immunity tests may have to be repeated by taking down the test setup and resetting it up so that there are a statistically significant number of repeat measurements to identify the measurement uncertainty. By combining the repeat measurement results with that of the instrumentation chain using the technique contained in NIS 81 and NIS 3003, the overall measurement uncertainty was estimated.

FCC ID: BEJCG300	 PCTEST Engineering Laboratory, Inc.	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 25 of 70

12. TEST DATA

See following Attached Pages for Test Data.

FCC ID: BEJCG300	 PCTEST Engineering Laboratory, Inc.	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 26 of 70

Date: 2/20/2006



PCTEST Hearing-Aid Compatibility Facility

DUT: HAC Dipole 835 MHz

Type: CD835V3

Serial: 1003

Communication System: CW; Frequency: 835 MHz;

Measurement Standard: DAS4 (High Precision Assessment)

DAS4 Configuration:

- Probe: ER3DV6 - SN2353; Calibrated: 8/2/2005
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn665; Calibrated: 8/8/2005
- Phantom: HAC; Type: SD HAC P01 BA;
- Measurement SW: DAS4, V4.6 Build 23;

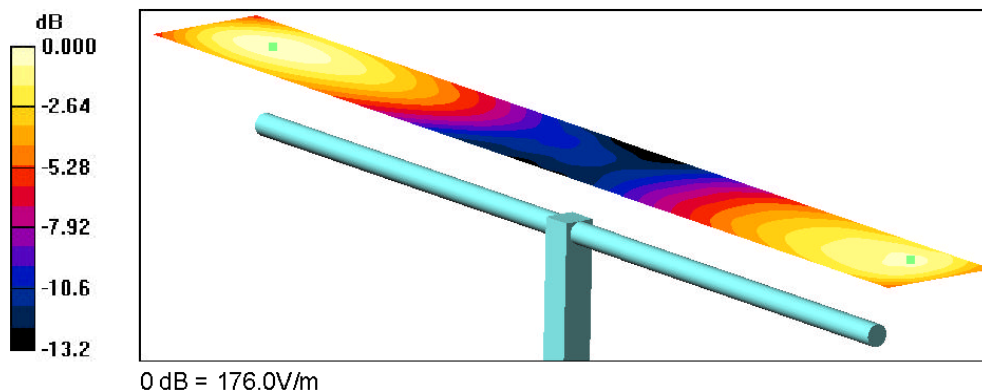
835MHz, 100mW/20dBm/Hearing Aid Compatibility Test (41x361x1): Measurement

grid: dx=5mm, dy=5mm

Probe Modulation Factor = 1.00

Reference Value = 110.4 V/m; Power Drift = -0.336 dB

Average value of Total (interpolated) = 169.8 V/m



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FCC ID: BEJCG300	PCTEST wireless	C63.19-2006 v3.12 HAC TEST REPORT	LG	Reviewed by: Quality Manager
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Date: 2/20/2006



PCTEST Hearing-Aid Compatibility Facility

DUT: HAC Dipole 835 MHz

Type: CD835V3

Serial: 1003

Communication System: CW; Frequency: 835 MHz;

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: H3DV6 - SN6170; Calibrated: 8/8/2005
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sr665; Calibrated: 8/8/2005
- Phantom: HAC; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.6 Build 23;

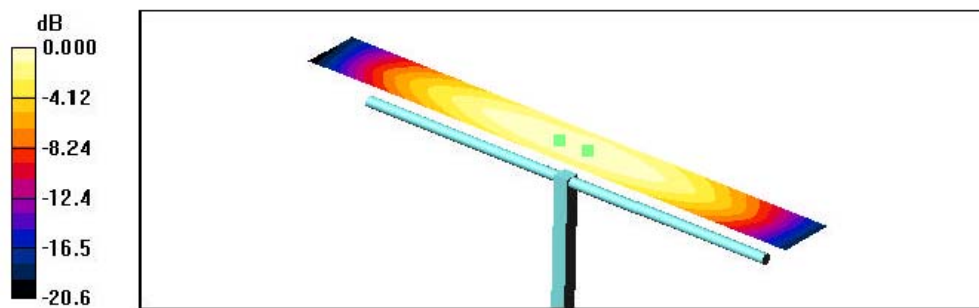
835MHz, 100mW/20dBm/Hearing Aid Compatibility Test (41x361x1): Measurement

grid: dx=5mm, dy=5mm

Probe Modulation Factor = 1.00

Reference Value = 0.519 A/m; Power Drift = -0.369 dB

Maximum value of Total (interpolated) = 0.474 A/m



0 dB = 0.474A/m

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FCC ID: BEJCG300	PCTEST wireless	C63.19-2006 v3.12 HAC TEST REPORT	LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 28 of 70

Date: 2/20/2006



PCTEST Hearing-Aid Compatibility Facility

DUT: HAC Dipole 1900 MHz

Type: CD1880V3
Serial: 1002

Communication System: CW; Frequency: 1880 MHz;

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ER3DV6 - SN2353; Calibrated: 8/2/2005
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn665; Calibrated: 8/8/2005
- Phantom: HAC; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.6 Build 23;

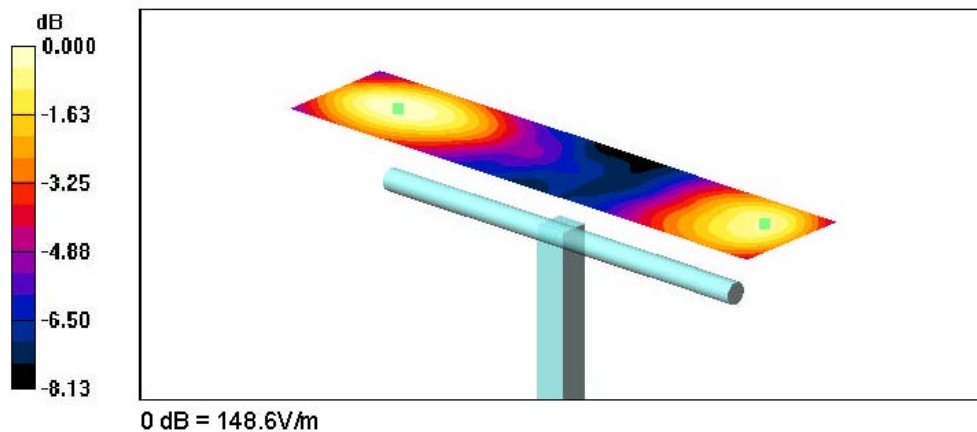
1880MHz, 100mW/20dBm/Hearing Aid Compatibility Test (41x181x1): Measurement

grid: dx=5mm, dy=5mm

Probe Modulation Factor = 1.00

Reference Value = 140.7 V/m; Power Drift = 0.198 dB

Maximum value of Total (interpolated) = 148.6 V/m



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FCC ID: BEJCG300	PCTEST wireless	C63.19-2006 v3.12 HAC TEST REPORT	LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 29 of 70

Date: 2/20/2006



PCTEST Hearing-Aid Compatibility Facility

DUT: HAC Dipole 1900 MHz

Type: CD1880V3

Serial: 1002

Communication System: CW; Frequency: 1880 MHz;

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: H3DV6 - SN6170; Calibrated: 8/8/2005
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn665; Calibrated: 8/8/2005
- Phantom: HAC; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.6 Build 23;

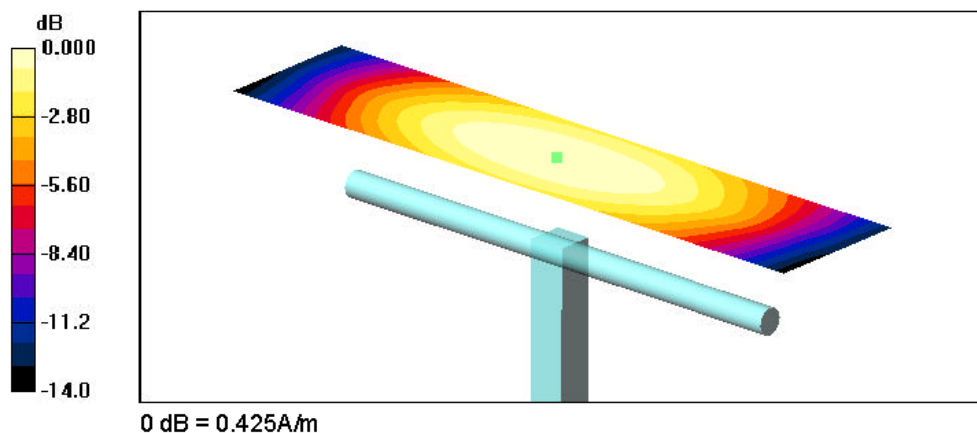
1880MHz, 100mW/20dBm/Hearing Aid Compatibility Test (41x181x1): Measurement

grid: dx=5mm, dy=5mm

Probe Modulation Factor = 1.00

Reference Value = 0.455 A/m; Power Drift = -0.050 dB

Maximum value of Total (interpolated) = 0.425 A/m



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FCC ID: BEJCG300	PCTEST wireless	C63.19-2006 v3.12 HAC TEST REPORT	LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 30 of 70



PCTEST Hearing-Aid Compatibility Facility

DUT: CG300

Type: LG Dual Band GSM Phone
 Serial: 602KPRW60390-CGR-P64
Backlight off
Duty Cycle: 1:8.3

Communication System: GSM850; Frequency: 836.6 MHz;

Measurement Standard: DASy4 (High Precision Assessment)

DASy4 Configuration:

- Probe: ER3DV6 - SN2353; Calibrated: 8/2/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn649; Calibrated: 9/13/2005
- Phantom: HAC Main; Type: SD HAC P01 BA;
- Measurement SW: DASy4, V4.6 Build23;

Mid.ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 182.9 V/m

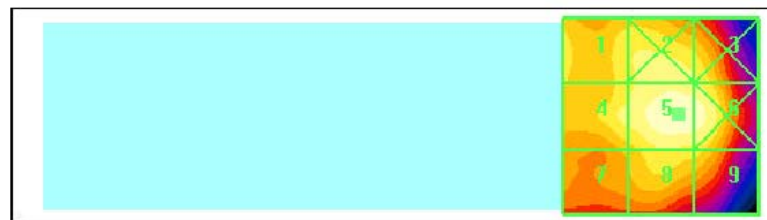
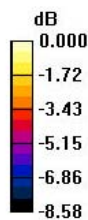
Probe Modulation Factor = 2.88

Reference Value = 62.5 V/m; Power Drift = 0.224 dB

Hearing Aid Near-Field Category: M1 (AWF -5 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
158.6	168.4	165.0
Grid 4	Grid 5	Grid 6
165.1	182.9	180.4
Grid 7	Grid 8	Grid 9
144.7	161.0	156.7



0 dB = 182.9V/m

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FCC ID: BEJCG300	PCTEST wireless	C63.19-2006 v3.12 HAC TEST REPORT	LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 31 of 70



PCTEST Hearing-Aid Compatibility Facility

DUT: CG300

Type: LG Dual Band GSM Phone
 Serial: 602KPRW60390-CGR-P64
Backlight off
Duty Cycle: 1:8.3

Communication System: GSM1900; Frequency: 1909.8 MHz;

Measurement Standard: DASy4 (High Precision Assessment)

DASy4 Configuration:

- Probe: ER3DV6 - SN2353; Calibrated: 8/2/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn649; Calibrated: 9/13/2005
- Phantom: HAC Main; Type: SD HAC P01 BA;
- Measurement SW: DASy4, V4.6 Build23;

High.ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 83.1 V/m

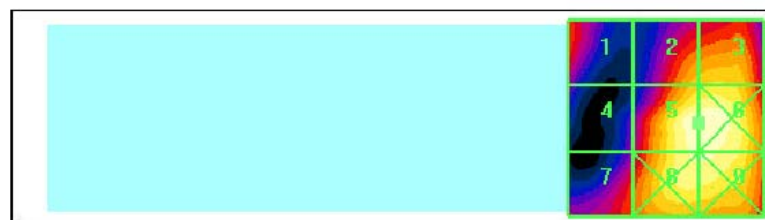
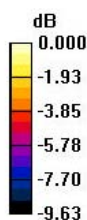
Probe Modulation Factor = 2.80

Reference Value = 20.5 V/m; Power Drift = 0.312 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
54.0	65.8	68.3
Grid 4	Grid 5	Grid 6
44.9	83.1	83.8
Grid 7	Grid 8	Grid 9
53.7	79.4	79.5



0 dB = 83.8V/m

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FCC ID: BEJCG300	PCTEST wireless	C63.19-2006 v3.12 HAC TEST REPORT	LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 32 of 70



PCTEST Hearing-Aid Compatibility Facility

DUT: CG300

Type: LG Dual Band GSM Phone
 Serial: 602KPRW60390-CGR-P64
Backlight off
Duty Cycle: 1:8.3

Communication System: GSM850; Frequency: 836.6 MHz;

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: H3DV6 - SN6170; Calibrated: 8/8/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn649; Calibrated: 9/13/2005
- Phantom: HAC Main; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.6 Build23;

Mid.ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.193 A/m

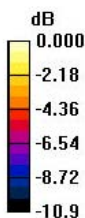
Probe Modulation Factor = 2.14

Reference Value = 0.069 A/m; Power Drift = 0.045 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.268	0.193	0.127
Grid 4	Grid 5	Grid 6
0.248	0.183	0.127
Grid 7	Grid 8	Grid 9
0.233	0.174	0.115



0 dB = 0.268A/m

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FCC ID: BEJCG300	C63.19-2006 v3.12 HAC TEST REPORT	LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone	Page 33 of 70



PCTEST Hearing-Aid Compatibility Facility

DUT: CG300

Type: LG Dual Band GSM Phone
 Serial: 602KPRW60390-CGR-P64
Backlight off
Duty Cycle: 1:8.3

Communication System: GSM1900; Frequency: 1909.8 MHz;

Measurement Standard: DASy4 (High Precision Assessment)

DASy4 Configuration:

- Probe: H3DV6 - SN6170; Calibrated: 8/8/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn649; Calibrated: 9/13/2005
- Phantom: HAC Main; Type: SD HAC P01 BA;
- Measurement SW: DASy4, V4.6 Build23;

High.ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.118 A/m

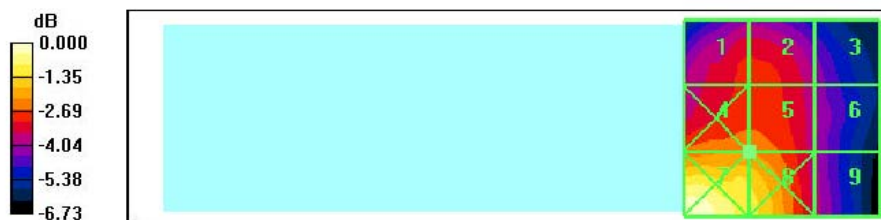
Probe Modulation Factor = 2.24

Reference Value = 0.048 A/m; Power Drift = -0.373 dB

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.109	0.110	0.095
Grid 4	Grid 5	Grid 6
0.119	0.118	0.098
Grid 7	Grid 8	Grid 9
0.153	0.134	0.100



0 dB = 0.153 A/m

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FCC ID: BEJCG300	C63.19-2006 v3.12 HAC TEST REPORT	LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone	Page 34 of 70

13. CALIBRATION CERTIFICATES

The following pages include the probe calibration used to evaluate HAC for the DUT.

FCC ID: BEJCG300	 PCTEST Engineering Laboratory, Inc.	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 35 of 70



Accredited by the Swiss Federal Office of Metrology and Accreditation
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **PC Test**

Certificate No: **ER3-2353_Aug05**

CALIBRATION CERTIFICATE

Object **ER3DV6 - SN:2353**

Calibration procedure(s) **QA CAL-02.v4
Calibration procedure for E-field probes optimized for close near field
evaluations in air**

Calibration date: **August 2, 2005**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	3-May-05 (METAS, No. 251-00466)	May-06
Power sensor E4412A	MY41495277	3-May-05 (METAS, No. 251-00466)	May-06
Power sensor E4412A	MY41498087	3-May-05 (METAS, No. 251-00466)	May-06
Reference 3 dB Attenuator	SN: S5054 (3c)	10-Aug-04 (METAS, No. 251-00403)	Aug-05
Reference 20 dB Attenuator	SN: S5086 (20b)	3-May-05 (METAS, No. 251-00467)	May-06
Reference 30 dB Attenuator	SN: S5129 (30b)	10-Aug-04 (METAS, No. 251-00404)	Aug-05
Reference Probe ER3DV6	SN: 2328	6-Oct-04 (SPEAG, No. ER3-2328_Oct04)	Oct-05
DAE4	SN: 617	7-Jul-05 (SPEAG, No. DAE4-617_Jul05)	Jul-06
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (SPEAG, in house check Dec-03)	In house check: Dec-05
Network Analyzer HP 8753E	US37390585	18-Oct-01 (SPEAG, in house check Nov-04)	In house check: Nov 05

	Name	Function	Signature
Calibrated by:	Katja Pokovic	Technical Manager	
Approved by:	Fin Bomholt	R&D Director	

Issued: August 8, 2005

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: ER3-2353_Aug05

Page 1 of 9

FCC ID: BEJCG300	PCTEST Engineering Laboratory	C63.19-2006 v3.12 HAC TEST REPORT	LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone	Page 36 of 70	

**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Federal Office of Metrology and Accreditation
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Glossary:

NORM_{x,y,z} sensitivity in free space
DCP diode compression point
Polarization ϕ ϕ rotation around probe axis
Polarization ϑ ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis
Connector Angle information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1309-1996, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", 1996.

Methods Applied and Interpretation of Parameters:

- **NORM_{x,y,z}**: Assessed for E-field polarization $\vartheta = 0$ for XY sensors and $\vartheta = 90$ for Z sensor ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide).
- **NORM(f)_{x,y,z}** = NORM_{x,y,z} * frequency_response (see Frequency Response Chart).
- **DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency.
- **Spherical isotropy (3D deviation from isotropy)**: in a locally homogeneous field realized using an open waveguide setup.
- **Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- **Connector Angle**: The angle is assessed using the information gained by determining the NORM_x (no uncertainty required).

FCC ID: BEJCG300	 C63.19-2006 v3.12 HAC TEST REPORT 	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone
		Page 37 of 70

Probe ER3DV6

SN:2353

Manufactured: March 8, 2005
Calibrated: August 2, 2005

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

FCC ID: BEJCG300	 PCTEST Engineering Laboratory, Inc.	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone	Page 38 of 70	

DASY - Parameters of Probe: ER3DV6 SN:2353Sensitivity in Free Space [$\mu\text{V}/(\text{V}/\text{m})^2$] Diode Compression^A

NormX	1.55 $\pm$ 10.1 % (k=2)	DCP X	95 mV
NormY	1.73 $\pm$ 10.1 % (k=2)	DCP Y	95 mV
NormZ	1.86 $\pm$ 10.1 % (k=2)	DCP Z	96 mV

Frequency Correction

X	0.0
Y	0.0
Z	0.0

Sensor Offset (Probe Tip to Sensor Center)

X	2.5 mm
Y	2.5 mm
Z	2.5 mm

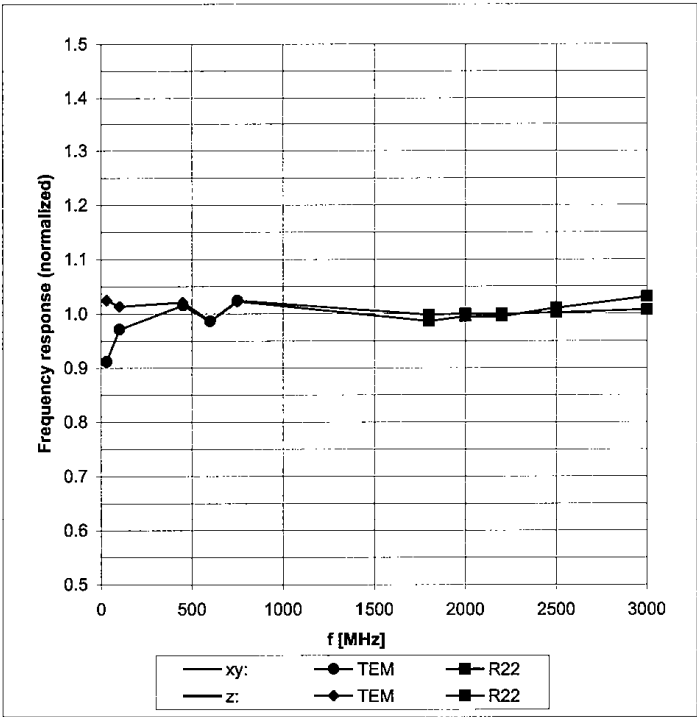
Connector Angle **29 °**

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A numerical linearization parameter: uncertainty not required

FCC ID: BEJCG300	 PCTEST Engineering Laboratory, Inc.	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 39 of 70

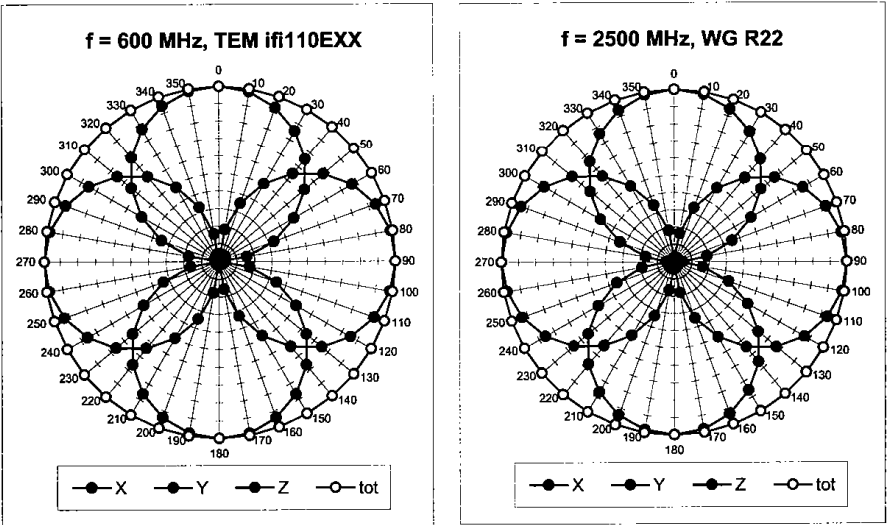
Frequency Response of E-Field
(TEM-Cell:ifi110 EXX, Waveguide R22)



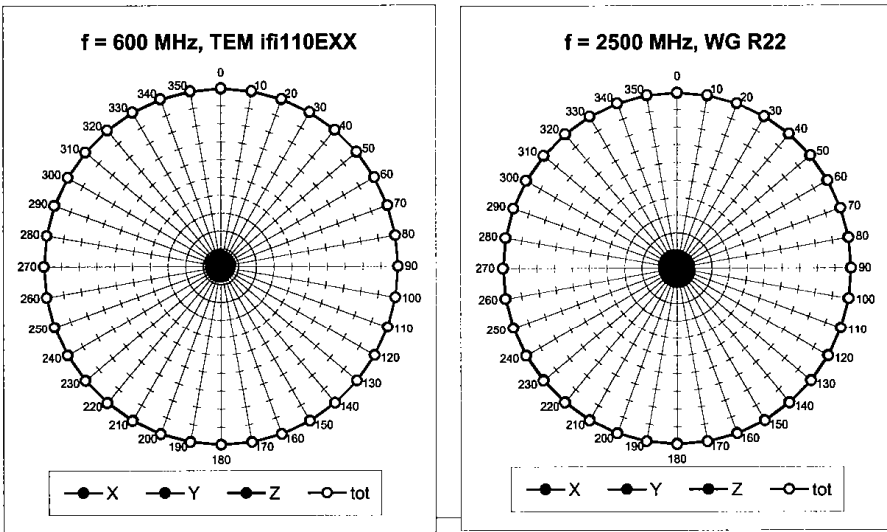
Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ (k=2)

FCC ID: BEJCG300	 PCTEST Engineering Laboratory, Inc.	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 40 of 70

Receiving Pattern (ϕ), $\vartheta = 0^\circ$

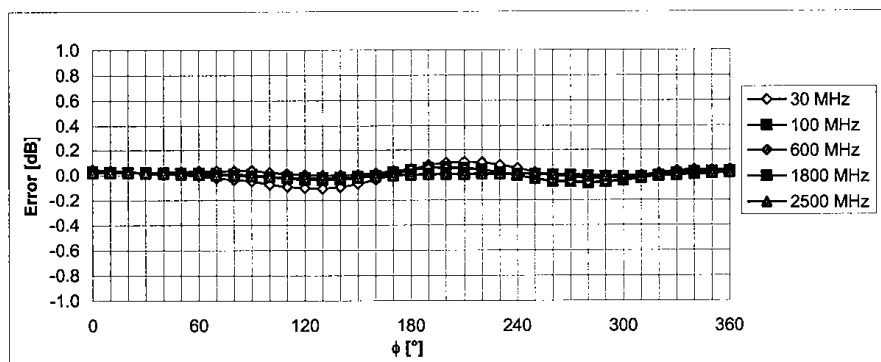


Receiving Pattern (ϕ), $\vartheta = 90^\circ$



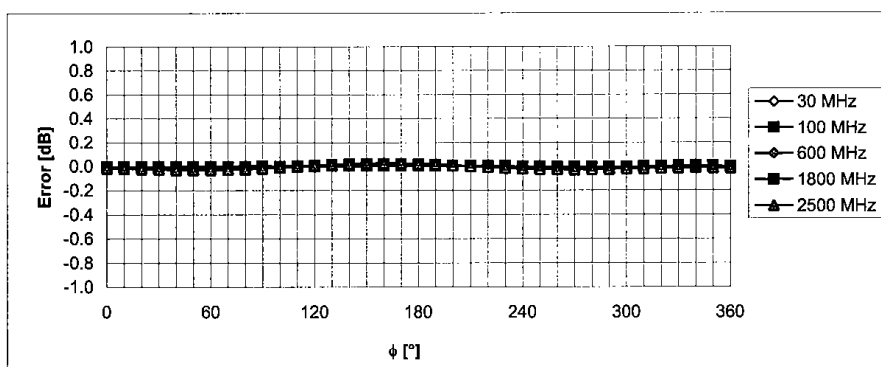
FCC ID: BEJCG300	 PCTEST	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 41 of 70

Receiving Pattern (ϕ), $\vartheta = 0^\circ$



Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

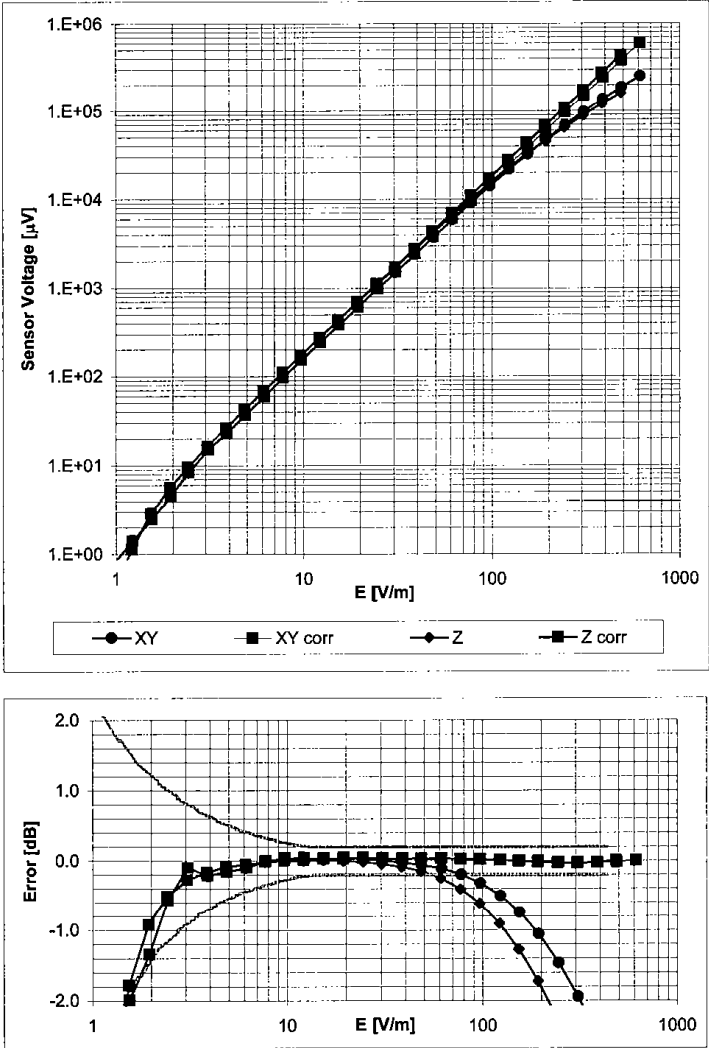
Receiving Pattern (ϕ), $\vartheta = 90^\circ$



Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

FCC ID: BEJCG300	 PCTEST wired & wireless	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 42 of 70

Dynamic Range f(E-field)
(Waveguide R22, f = 1800 MHz)

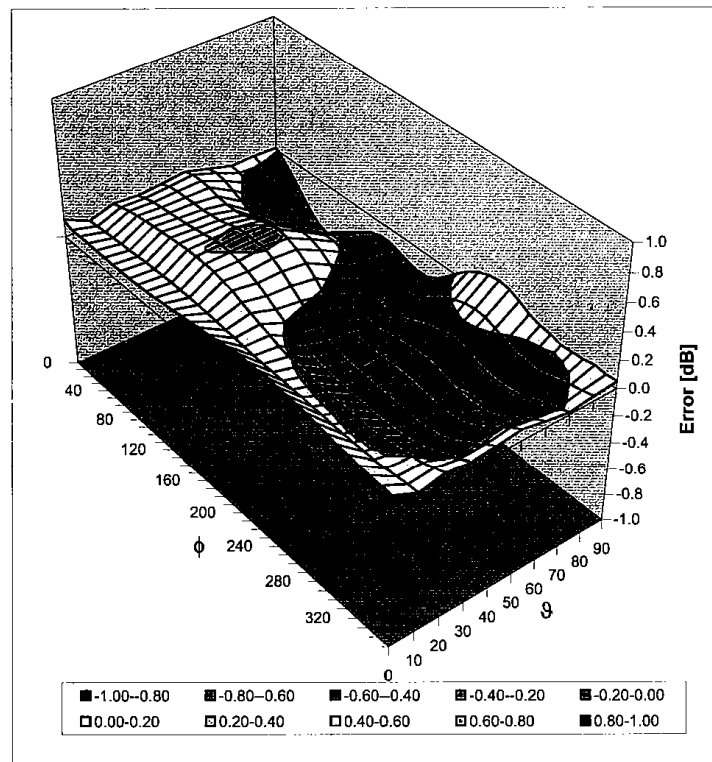


Uncertainty of Linearity Assessment: ± 0.6% (k=2)

FCC ID: BEJCG300	 PCTEST Engineering Laboratory, Inc.	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 43 of 70

Deviation from Isotropy in Air

Error (ϕ , ϑ), $f = 900$ MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ ($k=2$)

FCC ID: BEJCG300	 PCTEST Engineering Laboratory	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 44 of 70



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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **PC Test**

Certificate No: **H3-6170_Aug05**

CALIBRATION CERTIFICATE

Object **H3DV6 - SN:6170**

Calibration procedure(s) **QA CAL-03.v4
Calibration procedure for H-field probes optimized for close near field
evaluations in air**

Calibration date: **August 8, 2005**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	3-May-05 (METAS, No. 251-00466)	May-06
Power sensor E4412A	MY41495277	3-May-05 (METAS, No. 251-00466)	May-06
Power sensor E4412A	MY41498087	3-May-05 (METAS, No. 251-00466)	May-06
Reference 3 dB Attenuator	SN: S5054 (3c)	10-Aug-04 (METAS, No. 251-00403)	Aug-05
Reference 20 dB Attenuator	SN: S5086 (20b)	3-May-05 (METAS, No. 251-00467)	May-06
Reference 30 dB Attenuator	SN: S5129 (30b)	10-Aug-04 (METAS, No. 251-00404)	Aug-05
Reference Probe H3DV6	SN: 6182	6-Oct-04 (SPEAG, No. H3-6182_Oct04)	Oct-05
DAE4	SN: 617	7-Jul-05 (SPEAG, No. DAE4-617_Jul05)	Jul-06
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (SPEAG, in house check Dec-03)	In house check: Dec-05
Network Analyzer HP 8753E	US37390585	18-Oct-01 (SPEAG, in house check Nov-04)	In house check: Nov 05

	Name	Function	Signature
Calibrated by:	Katja Pokovic	Technical Manager	
Approved by:	Fin Bomholt	R&D Director	

Issued: August 8, 2005

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: H3-6170_Aug05

Page 1 of 8

FCC ID: BEJCG300	PCTEST Engineering Laboratory	C63.19-2006 v3.12 HAC TEST REPORT	LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 45 of 70

**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



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Accreditation No.: **SCS 108**

Glossary:

NORM_{x,y,z} sensitivity in free space
DCP diode compression point
Polarization ϕ ϕ rotation around probe axis
Polarization ϑ ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis
Connector Angle information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1309-1996, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", 1996.

Methods Applied and Interpretation of Parameters:

- **X, Y, Z_{a0a1a2}** : Assessed for E-field polarization $\vartheta = 90$ for XY sensors and $\vartheta = 0$ for Z sensor ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide).
- **$X, Y, Z(f)_{a0a1a2} = X, Y, Z_{a0a1a2} \cdot \text{frequency_response}$** (see Frequency Response Chart).
- **$DCP_{x,y,z}$** : DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency.
- **Spherical isotropy (3D deviation from isotropy)**: in a locally homogeneous field realized using an open waveguide setup.
- **Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- **Connector Angle**: The angle is assessed using the information gained by determining the X_{a0a1a2} (no uncertainty required).

FCC ID: BEJCG300	 PCTEST	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 46 of 70

Probe H3DV6

SN:6170

Manufactured: May 19, 2005
Calibrated: August 8, 2005

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

FCC ID: BEJCG300	 PCTEST Engineering Laboratory, Inc.	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 47 of 70

DASY - Parameters of Probe: H3DV6 SN:6170Sensitivity in Free Space [A/m / $\sqrt{(\mu V)}$]

	a0	a1	a2
X	2.502E-03	1.072E-4	-3.021E-6 $\pm$ 5.1 % (k=2)
Y	2.645E-03	2.739E-6	-2.811E-5 $\pm$ 5.1 % (k=2)
Z	2.960E-03	-6.594E-5	2.809E-5 $\pm$ 5.1 % (k=2)

Diode Compression¹

DCP X	85 mV
DCP Y	85 mV
DCP Z	86 mV

Sensor Offset (Probe Tip to Sensor Center)

X	3.0 mm
Y	3.0 mm
Z	3.0 mm

Connector Angle 29 °

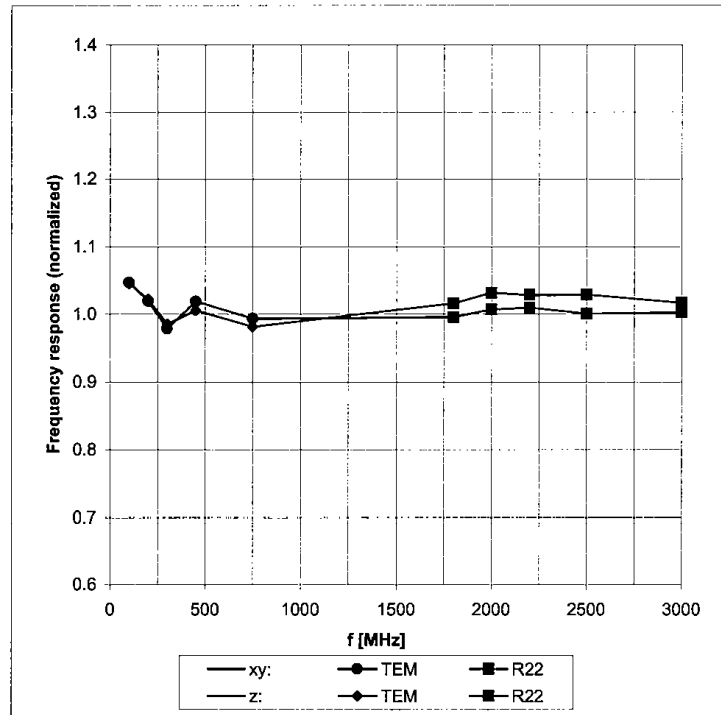
The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

¹ numerical linearization parameter: uncertainty not required

FCC ID: BEJCG300	 PCTEST wireless	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 48 of 70

Frequency Response of H-Field

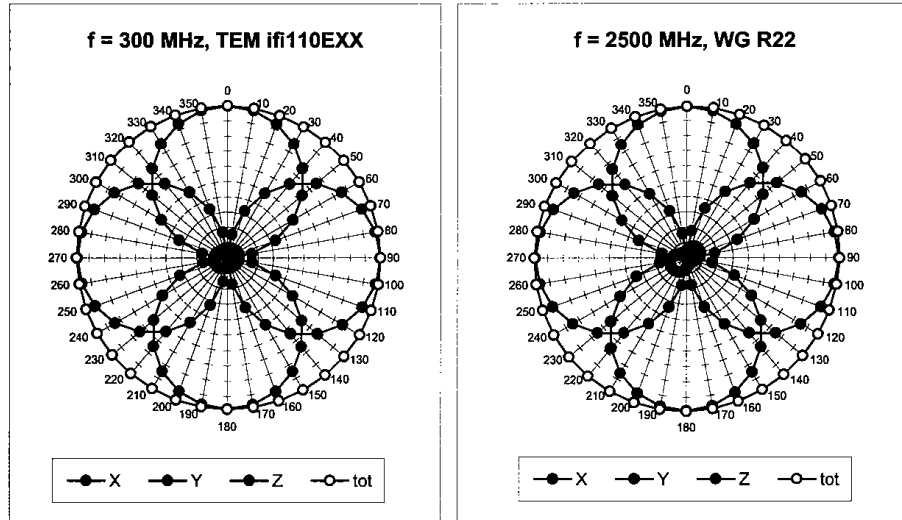
(TEM-Cell:ifi110, Waveguide R22)



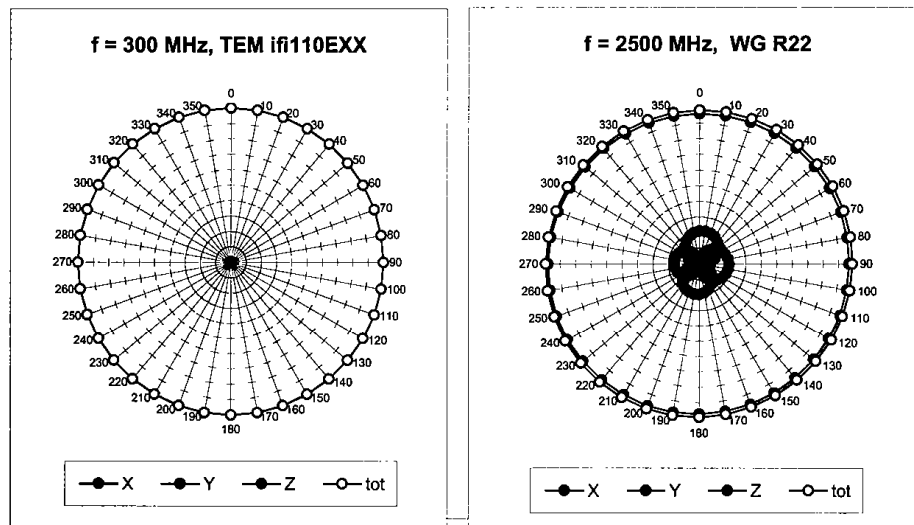
Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

FCC ID: BEJCG300	 PCTEST wireless	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 49 of 70

Receiving Pattern (ϕ), $\theta = 90^\circ$

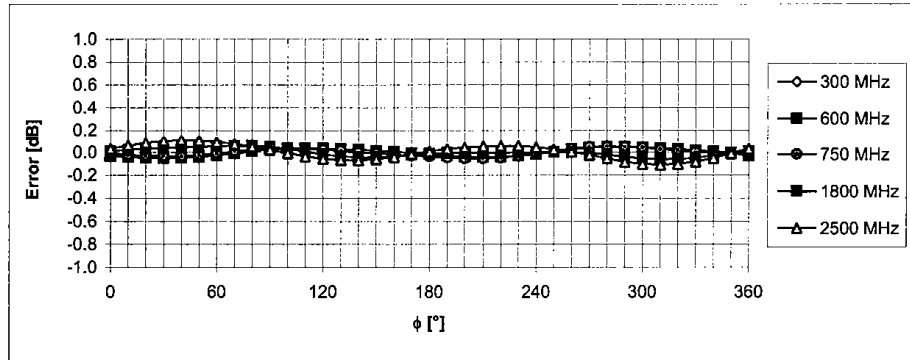


Receiving Pattern (ϕ), $\theta = 0^\circ$



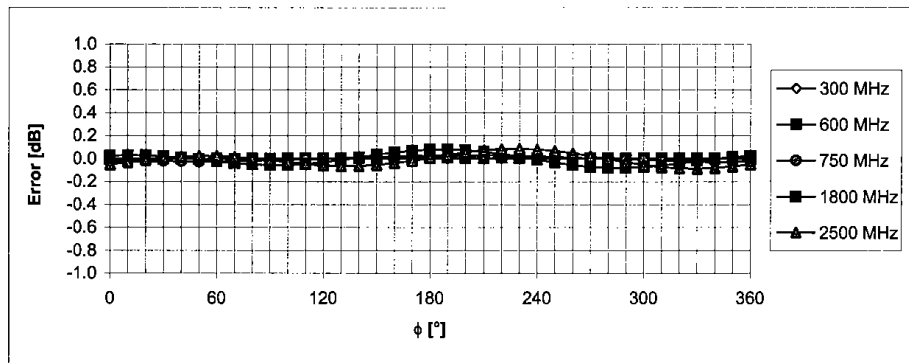
FCC ID: BEJCG300	 PCTEST wireless	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 50 of 70

Receiving Pattern (ϕ), $\vartheta = 90^\circ$



Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

Receiving Pattern (ϕ), $\vartheta = 0^\circ$

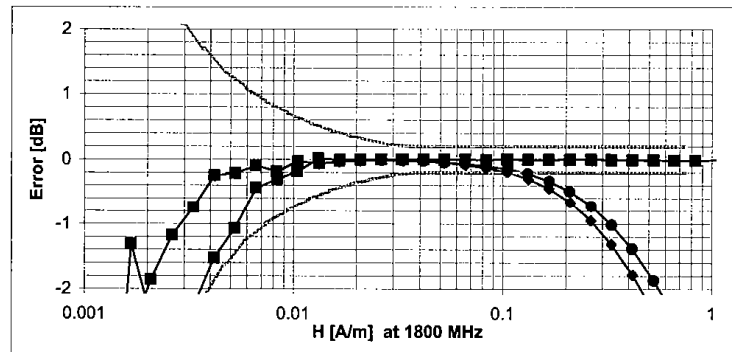
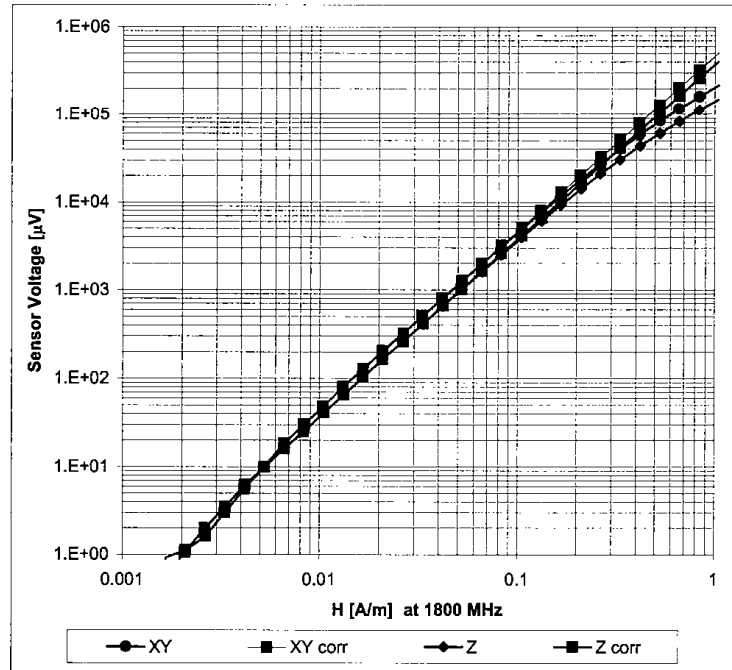


Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

FCC ID: BEJCG300	 PCTEST Engineering Laboratory, Inc.	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 51 of 70

Dynamic Range f(H-field)

(Waveguide R22, f = 1800 MHz)



Uncertainty of Linearity Assessment: $\pm 0.6\%$ (k=2)

FCC ID: BEJCG300	 PCTEST	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 52 of 70

Client

PC TEST

Certificate No: CD1880V3-1002_Feb05

CALIBRATION CERTIFICATE

Object **CD1880V3 - SN: 1002**

Calibration procedure(s) **QA CAL-20.v2
Calibration procedure for dipoles in air**

Calibration date: **February, 23, 2005**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Power meter EPM E442	GB37480704	12-Oct-04 (METAS, No. 251-00412)	Oct-05
Power sensor HP 8481A	US37292783	12-Oct-04 (METAS, No. 251-00412)	Oct-05
Reference 20 dB Attenuator	SN: 5086 (20g)	10-Aug-04 (METAS, No 251-00402)	Aug-05
Reference 10 dB Attenuator	SN: 5047.2 (10r)	10-Aug-04 (METAS, No 251-00402)	Aug-05
Reference Probe ER3DV6	SN 2328	06-Oct-04 (SPEAG, No. ER3-2328_Oct04)	Oct-05
DAE4	SN 601	07-Jan-05 (SPEAG, No. DAE4-601_Jan05)	Jan-06
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092312	10-Aug-03 (SPEAG, in house check Jan-04)	In house check: Oct-05
Power sensor HP 8481A	MY41093315	10-Aug-03 (SPEAG, in house check Jan-04)	In house check: Oct-05
RF generator Agilent E8251A	US41140111	4-Aug-03 (Agilent)	In house check: Aug-05
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (SPEAG, in house check Nov-04)	In house check: Nov-05
Probe H3DV6	SN: 6065	10-Oct-04 (SPEAG, No. H3-6065-Oct04)	Calibration, Oct-05

	Name	Function	Signature
Calibrated by:	Mike Meili	Laboratory Technician	
Approved by:	Fin Bornholt	Technical Director	

Issued: February 27, 2005

This calibration certificate is issued as an intermediate solution until the specific calibration procedure is submitted and accepted in the frame of the accreditation of the Calibration Laboratory of Schmid & Partner Engineering AG (based on ISO/IEC 17025 International Standard)

Certificate No: CD1880V3-1002_Feb05

Page 1 of 6

FCC ID: BEJCG300		C63.19-2006 v3.12 HAC TEST REPORT		Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 53 of 70

References

- [1] ANSI-PC63.19-2003 (Draft)
American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- **Coordinate System:** y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with standard [1], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- **Measurement Conditions:** Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- **Antenna Positioning:** The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY4 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- **Feed Point Impedance and Return Loss:** These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- **E-field distribution:** E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- **H-field distribution:** H-field is measured with an isotropic H-field probe with 100mW forward power to the antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the feed point.

FCC ID: BEJCG300	 PCTEST Engineering Laboratory	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 54 of 70

1 Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY4	V4.5 B13
DASY PP Version	SEMCAD	V1.8 B144
Phantom	HAC Test Arch	SD HAC P01 BA, #1002
Distance Dipole Top - Probe Center	10 mm	
Scan resolution	dx, dy = 5 mm	area = 20 x 90 mm
Frequency	1880 MHz $\pm$ 1 MHz	
Forward power at dipole connector	20.0 dBm = 100mW	
Input power drift	< 0.05 dB	

2 Maximum Field values

H-field 10 mm above dipole surface	condition	interpolated maximum
Maximum measured	100 mW forward power	0.450 A/m

Uncertainty for H-field measurement: 19.5% (k=2)

E-field 10 mm above dipole surface	condition	interpolated maximum
Maximum measured above high end	100 mW forward power	146.0 V/m
Maximum measured above low end	100 mW forward power	145.6 V/m
Averaged maximum above arm	100 mW forward power	145.8 V/m

Uncertainty for E-field measurement: 21.7% (k=2)

3 Appendix

3.1 Antenna Parameters

Frequency	Return Loss	Impedance
1710 MHz	23.4 dB	(55.2 + j6.1) Ohm
1880 MHz	21.4 dB	(53.9 + j7.4) Ohm
1900 MHz	20.9 dB	(55.8 + j6.7) Ohm
1950 MHz	28.0 dB	(54.1 + j1.9) Ohm
2000 MHz	18.9 dB	(51.2 + j11.9) Ohm

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

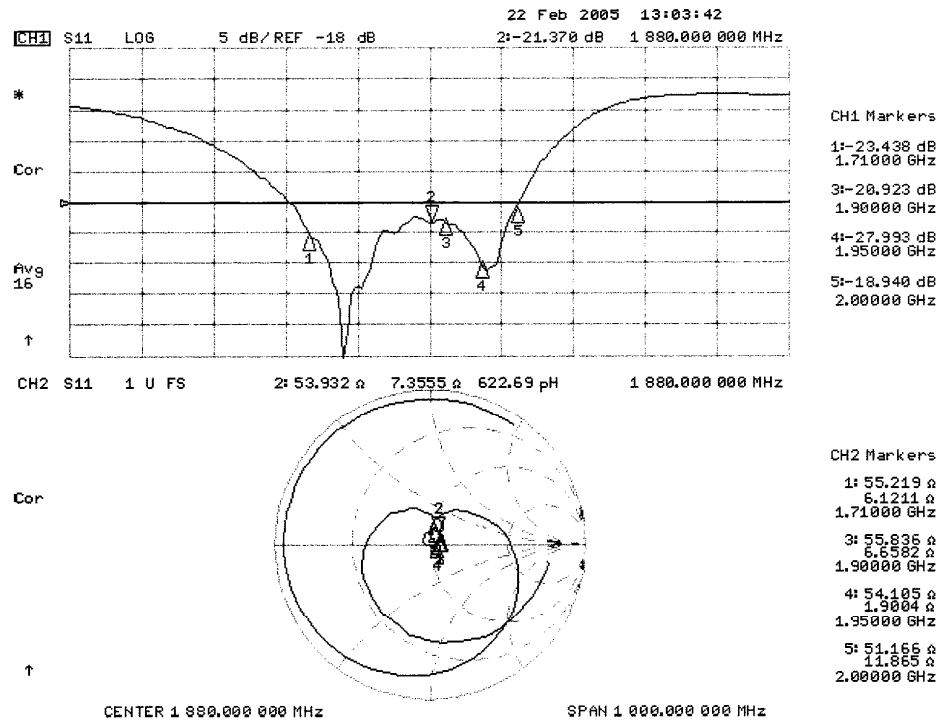
Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

FCC ID: BEJCG300	 PCTEST Engineering Laboratory, Inc.	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 55 of 70

3.3 Measurement Sheets

3.3.1 Return Loss and Smith Chart



3.3.2 DASY4 H-field result

See page 5

3.3.3 DASY4 E-Field result

See page 6

Certificate No: CD1880V3-1002_Feb05

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FCC ID: BEJCG300	 PCTEST microelectronics	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 56 of 70

Test Laboratory: SPEAG, Zurich, Switzerland
 File Name: H_CD1880_1002_050223.da4

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1002
Program Name: HAC H Dipole

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$; mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Dipole Section

DASY4 Configuration:

- Probe: H3DV6 - SN6065; ; Calibrated: 10.12.2004
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn901; Calibrated: 29.06.2004
- Phantom: HAC Phantom; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.5 Build 13; Postprocessing SW: SEMCAD, V1.8 Build 144

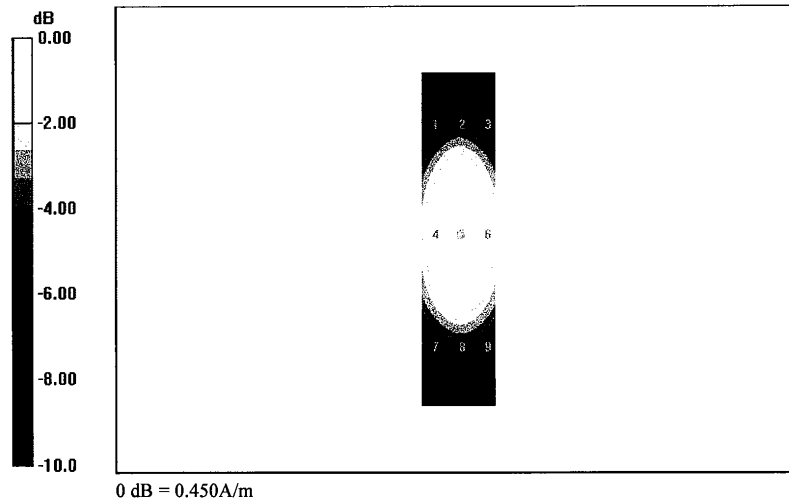
H Scan 10mm above CD 1880 MHz/Hearing Aid Compatibility Test (41x181x1): Measurement grid: dx=5mm, dy=5mm, dz=5.5555mm

Maximum value of Total field (slot averaged) = 0.450 A/m

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

H in A/m (Time averaged) H in A/m (Slot averaged)

Grid 1	Grid 2	Grid 3	Grid 1	Grid 2	Grid 3
0.385	0.413	0.395	0.385	0.413	0.395
Grid 4	Grid 5	Grid 6	Grid 4	Grid 5	Grid 6
0.421	0.450	0.432	0.421	0.450	0.432
Grid 7	Grid 8	Grid 9	Grid 7	Grid 8	Grid 9
0.376	0.401	0.386	0.376	0.401	0.386



FCC ID: BEJCG300	 PCTEST Engineering Laboratory, Inc.	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 57 of 70

Test Laboratory: SPEAG, Zurich, Switzerland
 File Name: E_CD1880_1002_050223.da4

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: 1002
Program Name: HAC E Dipole

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$; ρ_{ho}/m ; $\epsilon_r = 1$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: E Dipole Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2328; ConvF(1, 1, 1); Calibrated: 06.10.2004
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn901; Calibrated: 29.06.2004
- Phantom: HAC Phantom; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.5 Build 13; Postprocessing SW: SEMCAD, V1.8 Build 144

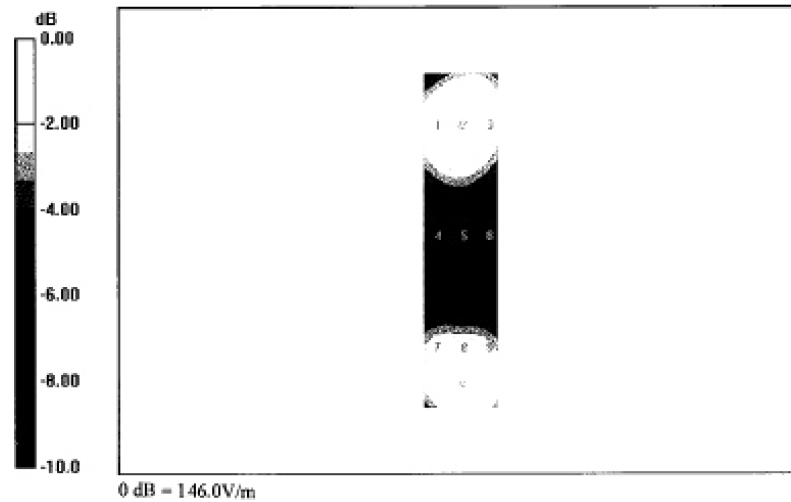
E Scan 10mm above CD 1880 MHz/Hearing Aid Compatibility Test (41x181x1): Measurement grid: dx=5mm, dy=5mm, dz=5.5555mm

Maximum value of Total field (slot averaged) = 146.0 V/m

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

E in V/m (Time averaged) E in V/m (Slot averaged)

Grid 1	Grid 2	Grid 3	Grid 1	Grid 2	Grid 3
128.7	145.6	130.5	128.7	145.6	130.5
Grid 4	Grid 5	Grid 6	Grid 4	Grid 5	Grid 6
90.1	92.4	88.8	90.1	92.4	88.8
Grid 7	Grid 8	Grid 9	Grid 7	Grid 8	Grid 9
126.7	146.0	131.8	126.7	146.0	131.8



FCC ID: BEJCG300	 PCTEST Engineering Laboratory	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 58 of 70

Client

PC TEST

Certificate No: CD835V3-1003_Feb05

CALIBRATION CERTIFICATE

Object CD835V3 - SN: 1003

Calibration procedure(s) QA CAL-20 v2
Calibration procedure for dipoles in air

Calibration date: February 23, 2005

Condition of the calibrated item In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
All calibrations have been conducted in the closed laboratory facility: environment temperature ($22 \pm 3^\circ\text{C}$) and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Power meter EPM E442	GB37480704	12-Oct-04 (METAS, No. 251-00412)	Oct-05
Power sensor HP 8481A	US37292783	12-Oct-04 (METAS, No. 251-00412)	Oct-05
Reference 20 dB Attenuator	SN: 5086 (20g)	10-Aug-04 (METAS, No 251-00402)	Aug-05
Reference 10 dB Attenuator	SN: 5047.2 (10r)	10-Aug-04 (METAS, No 251-00402)	Aug-05
Reference Probe ER3DV6	SN 2328	06-Oct-04 (SPEAG, No. ER3-2328_Oct04)	Oct-05
DAE4	SN 601	07-Jan-05 (SPEAG, No. DAE4-601_Jan05)	Jan-06

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092312	10-Aug-03 (SPEAG, in house check Jan-04)	In house check: Oct-05
Power sensor HP 8481A	MY41093315	10-Aug-03 (SPEAG, in house check Jan-04)	In house check: Oct-05
RF generator Agilent E8251A	US41140111	4-Aug-03 (Agilent)	In house check: Aug-05
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (SPEAG, in house check Nov-04)	In house check: Nov-05
Probe H3DV6	SN: 6065	10-Oct-04 (SPEAG, No. H3-6065-Oct04)	Calibration, Oct-05

	Name	Function	Signature
Calibrated by:	Mike Meil	Laboratory Technician	
Approved by:	Fin Bornholt	Technical Director	

Issued: February 27, 2005

This calibration certificate is issued as an intermediate solution until the specific calibration procedure is submitted and accepted in the frame of the accreditation of the Calibration Laboratory of Schmid & Partner Engineering AG (based on ISO/IEC 17025 International Standard)

Certificate No: CD835V3-1003_Feb05

Page 1 of 6

FCC ID: BEJCG300		C63.19-2006 v3.12 HAC TEST REPORT		Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 59 of 70

References

- [1] ANSI-PC63.19-2003 (Draft)
 American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- **Coordinate System:** y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with standard [1], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- **Measurement Conditions:** Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- **Antenna Positioning:** The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY4 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- **Feed Point Impedance and Return Loss:** These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- **E-field distribution:** E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- **H-field distribution:** H-field is measured with an isotropic H-field probe with 100mW forward power to the antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the feed point.

FCC ID: BEJCG300	 PCTEST engineering	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 60 of 70

1 Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY4	V4.5 B13
DASY PP Version	SEMCAD	V1.8 B144
Phantom	HAC Test Arch	SD HAC P01 BA, #1002
Distance Dipole Top - Probe Center	10 mm	
Scan resolution	dx, dy = 5 mm	area = 20 x 180 mm
Frequency	835 MHz $\pm$ 1 MHz	
Forward power at dipole connector	20.0 dBm = 100mW	
Input power drift	< 0.05 dB	

2 Maximum Field values

H-field 10 mm above dipole surface	condition	interpolated maximum
Maximum measured	100 mW forward power	0.470 A/m

Uncertainty for H-field measurement: 19.5% (k=2)

E-field 10 mm above dipole surface	condition	interpolated maximum
Maximum measured above high end	100 mW forward power	187.0 V/m
Maximum measured above low end	100 mW forward power	183.2 V/m
Averaged maximum above arm	100 mW forward power	185.1 V/m

Uncertainty for E-field measurement: 21.7% (k=2)

3 Appendix

3.1 Antenna Parameters

Frequency	Return Loss	Impedance
800 MHz	16.6 dB	(40.5 - j9.6) Ohm
835 MHz	25.2 dB	(55.3 + j2.4) Ohm
900 MHz	16.6 dB	(52.7 - j15.2) Ohm
950 MHz	25.1 dB	(50.9 + j5.5) Ohm
960 MHz	17.2 dB	(61.0 + j10.9) Ohm

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

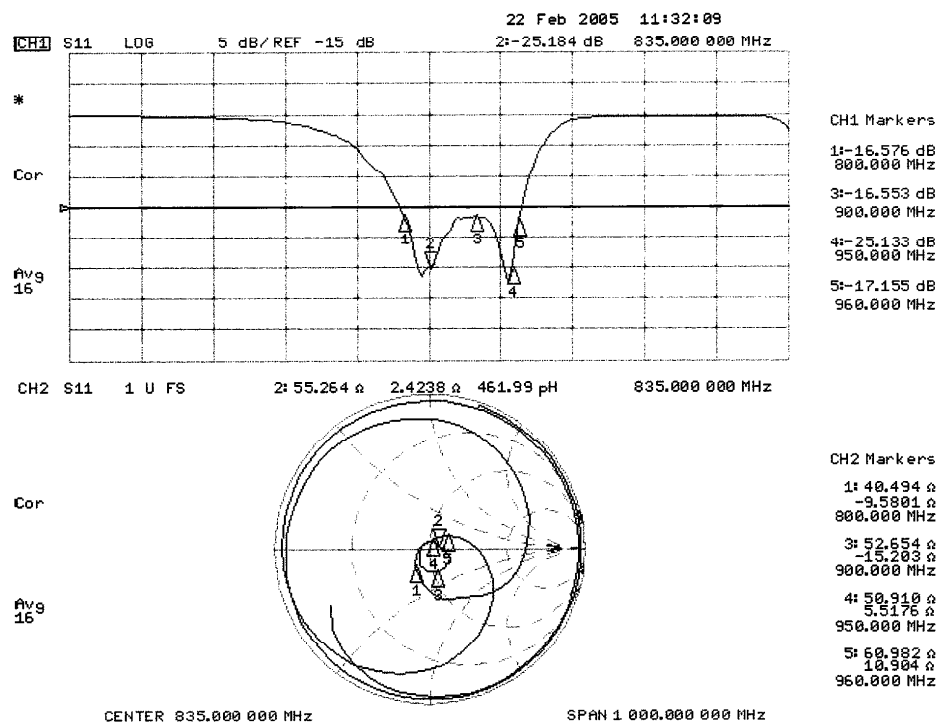
Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

FCC ID: BEJCG300	 PCTEST Engineering Laboratory, Inc.	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 61 of 70

3.3 Measurement Sheets

3.3.1 Return Loss and Smith Chart



3.3.2 DASY4 H-field result

See page 5

3.3.3 DASY4 E-Field result

See page 6

Certificate No: CD835V3-1003_Feb05

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FCC ID: BEJCG300	 PCTEST	C63.19-2006 v3.12 HAC TEST REPORT	 LG	Reviewed by: Quality Manager
HAC Filename: HAC.0603010132-R1.BEJ	Test Dates: March 1, 2006	EUT Type: Dual-Band GSM Phone		Page 62 of 70

Test Laboratory: SPEAG, Zurich, Switzerland
 File Name: H_CD835_1003_050222.da4

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1003
Program Name: HAC H Dipole

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$; mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: H Dipole Section

DASY4 Configuration:

- Probe: H3DV6 - SN6065; ; Calibrated: 10.12.2004
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn901; Calibrated: 29.06.2004
- Phantom: HAC Phantom; Type: SD HAC P01 BA; Serial: 1002
- Measurement SW: DASY4, V4.5 Build 13; Postprocessing SW: SEMCAD, V1.8 Build 144

H Scan 10mm above CD 835 MHz/Hearing Aid Compatibility Test (41x361x1): Measurement grid: dx=5mm,

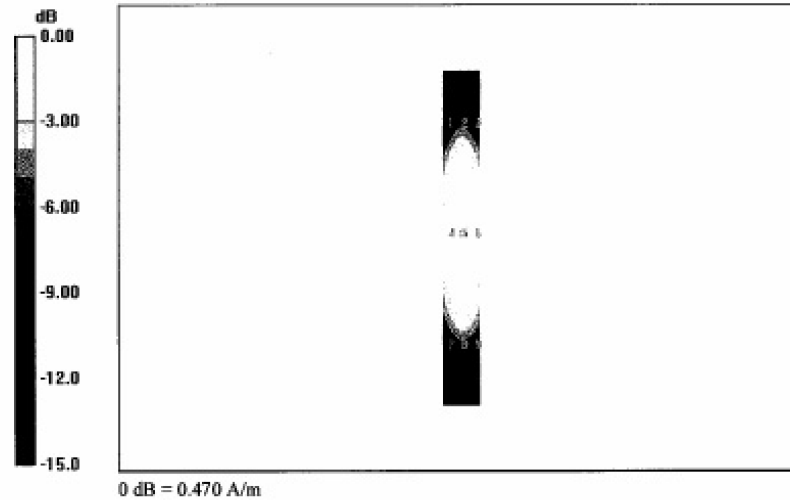
dy=5mm, dz=5.555mm

Maximum value of Total field (slot averaged) = 0.470 A/m

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

H in A/m (Time averaged) H in A/m (Slot averaged)

Grid 1	Grid 2	Grid 3	Grid 1	Grid 2	Grid 3
0.365	0.397	0.380	0.365	0.397	0.380
Grid 4	Grid 5	Grid 6	Grid 4	Grid 5	Grid 6
0.408	0.470	0.425	0.408	0.470	0.425
Grid 7	Grid 8	Grid 9	Grid 7	Grid 8	Grid 9
0.350	0.380	0.368	0.350	0.380	0.368



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Test Laboratory: SPEAG, Zurich, Switzerland
 File Name: E_CD835_1003_050223.da4

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial: 1003
Program Name: HAC E Dipole

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$; mho/m, $\epsilon_r = 1$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: E Dipole Section

DASY4 Configuration:

- Probe: ER3DV6 - SN2328; ConvF(1, 1, 1); Calibrated: 06.10.2004
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn901; Calibrated: 29.06.2004
- Phantom: HAC Phantom; Type: SD HAC P01 BA; Serial: 1002
- Measurement SW: DASY4, V4.5 Build 13; Postprocessing SW: SEMCAD, V1.8 Build 144

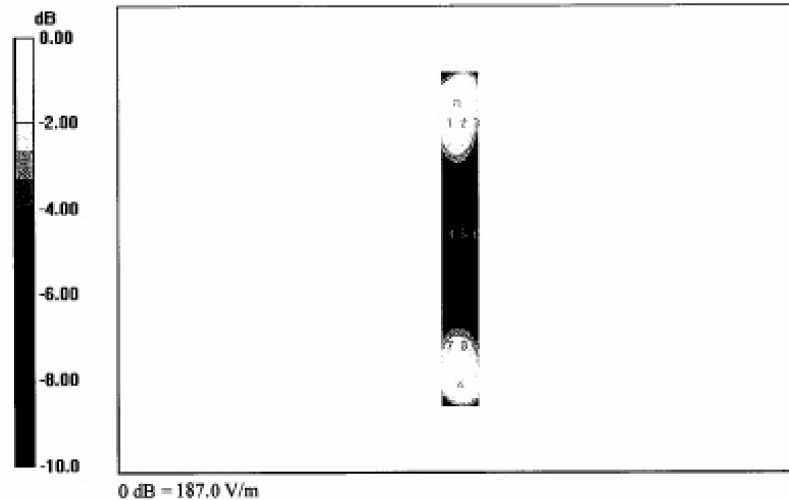
E Scan 10mm above CD 835 MHz/Hearing Aid Compatibility Test (41x361x1): Measurement grid: dx=5mm, dy=5mm, dz=5.555mm

Maximum value of Total field (slot averaged) = 187.0 V/m

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

E in V/m (Time averaged) E in V/m (Slot averaged)

Grid 1	Grid 2	Grid 3	Grid 1	Grid 2	Grid 3
156.0	187.0	150.1	156.0	187.0	150.1
Grid 4	Grid 5	Grid 6	Grid 4	Grid 5	Grid 6
83.6	84.8	80.4	83.6	84.8	80.4
Grid 7	Grid 8	Grid 9	Grid 7	Grid 8	Grid 9
148.0	183.2	149.5	148.0	183.2	149.5



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14. CONCLUSION

The measurements indicate that the wireless communications device complies with the HAC limits specified in accordance with the ANSI C63.19 Standard and FCC WT Docket No. 01-309 RM-8658. Precise laboratory measures were taken to assure repeatability of the tests. The tested device complies with the requirements in respect to all parameters specific to the test. The test results and statements relate only to the item(s) tested.

Please note that the M-rating for this equipment only represents the field interference possible against a hypothetical and typical hearing aid. The measurement system and techniques presented in this evaluation are proposed in the ANSI standard as a means of best approximating wireless device compatibility with a hearing-aid. The literature is under continual re-construction.

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